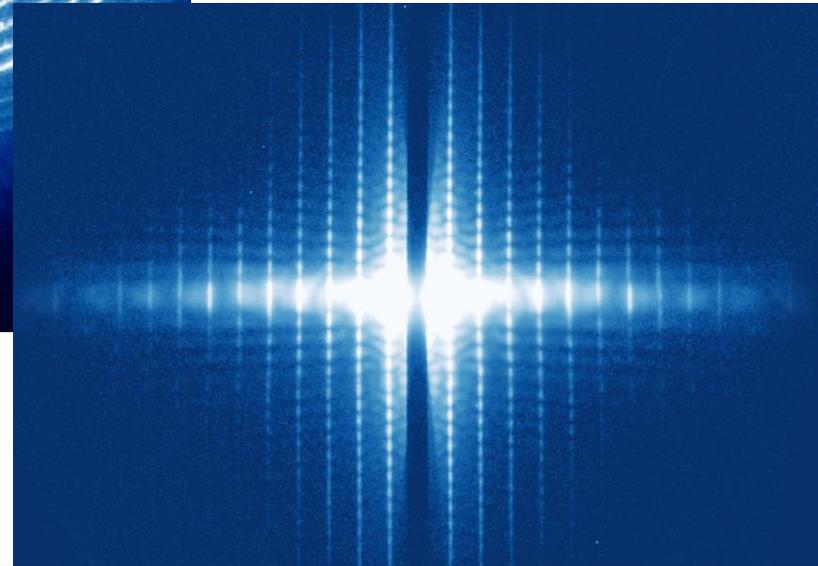
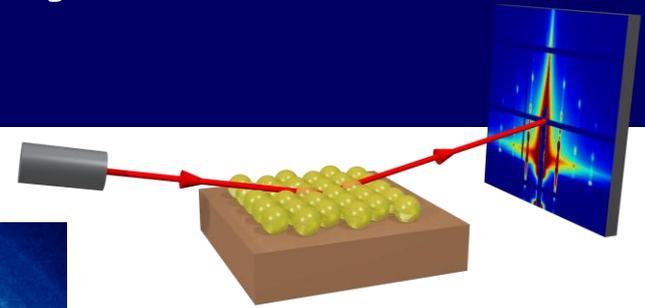
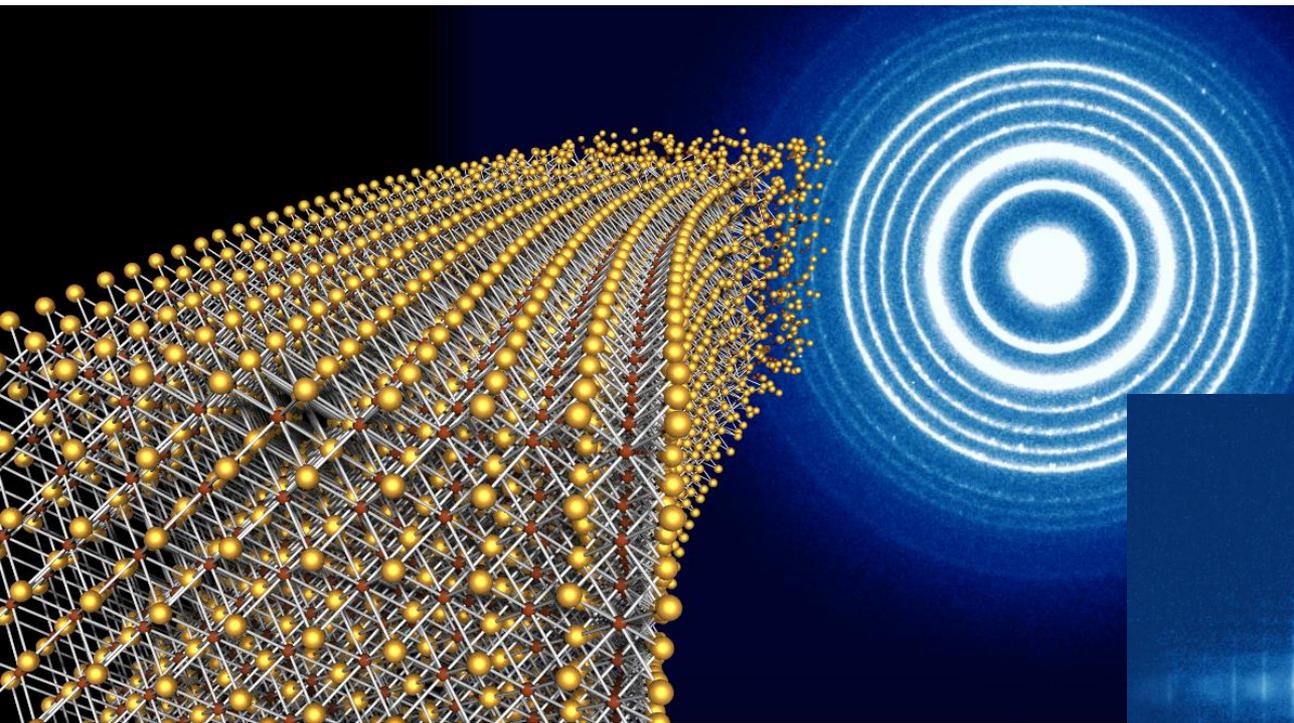
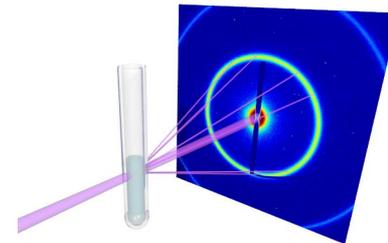


# Synchrotron Scattering for Study of Soft Systems



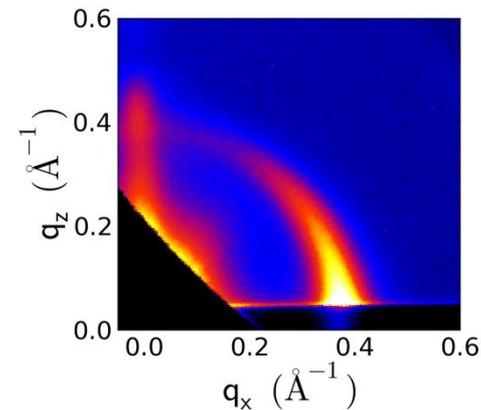
Kevin G. Yager

- X-ray scattering for nanoscience



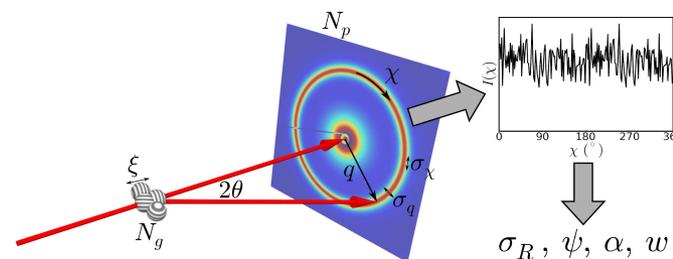
- Experimental examples:

- P3HT
- Block-copolymers
- 2D nanoparticle assembly



- New techniques:

- Variance scattering
- GTSAXS
- Nano-lattice model



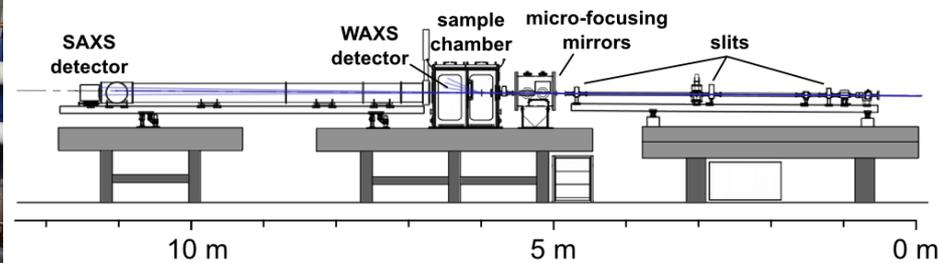
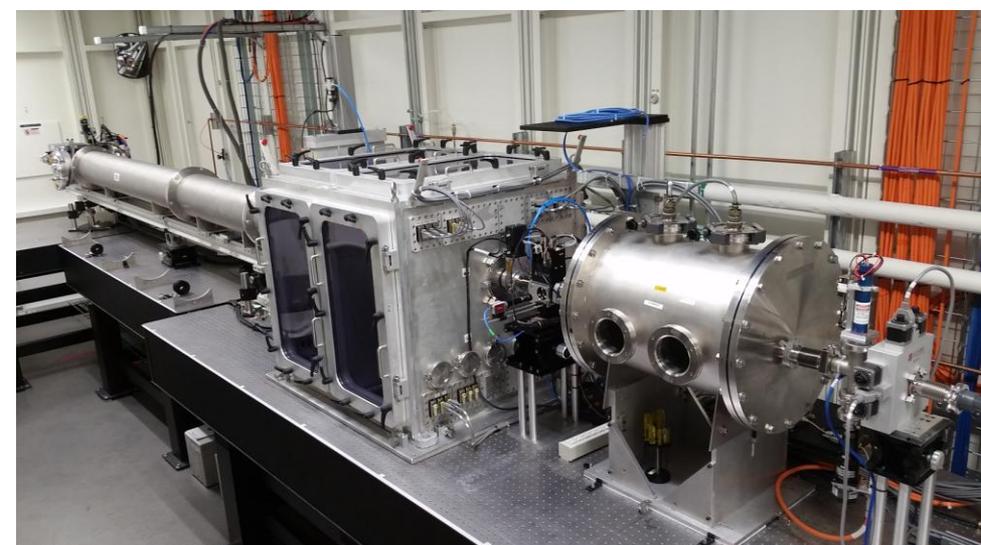
## NSLS-II (USA)



## SOLEIL (France)

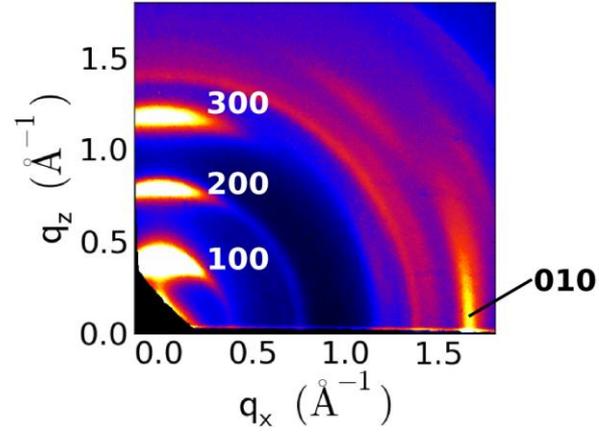
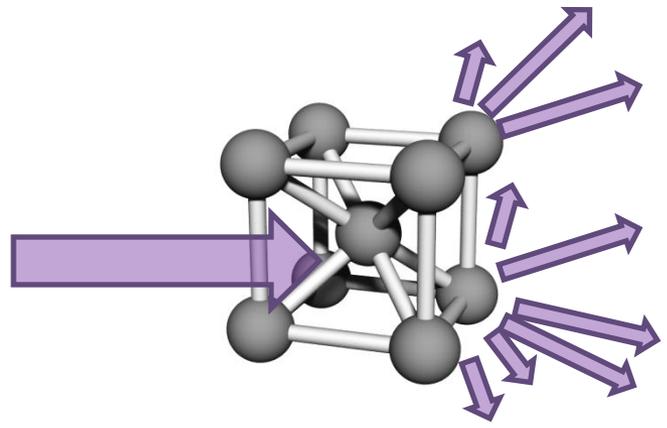
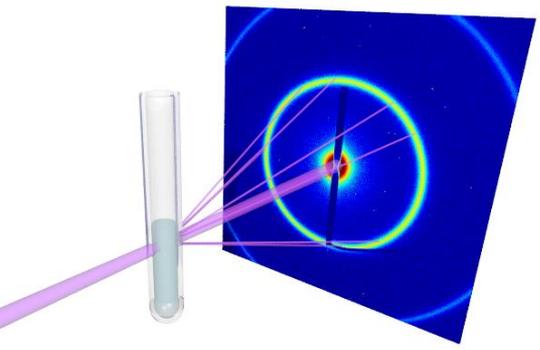


## CMS beamline at NSLS-II



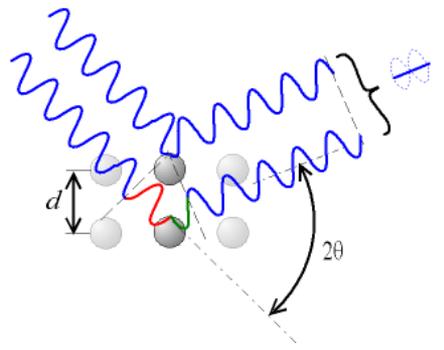
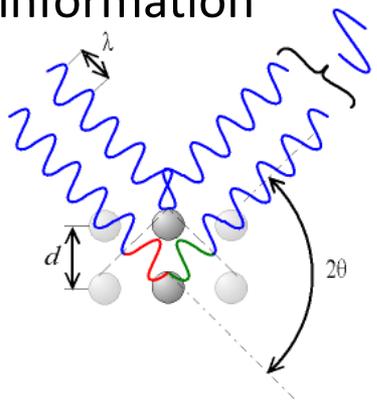
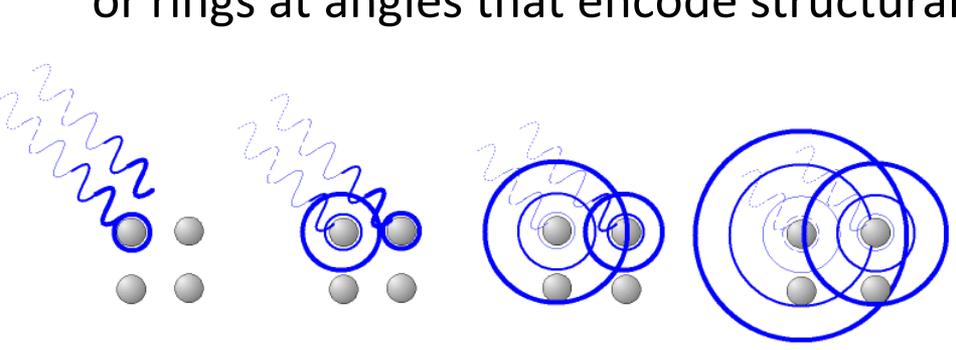
# X-ray Scattering

- X-rays scatter off of all the atoms/particles in the sample



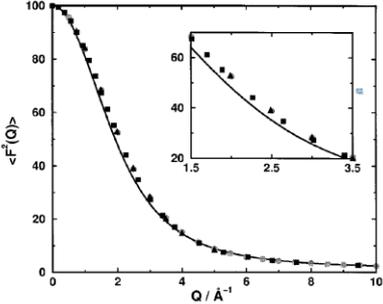
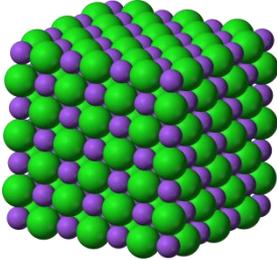
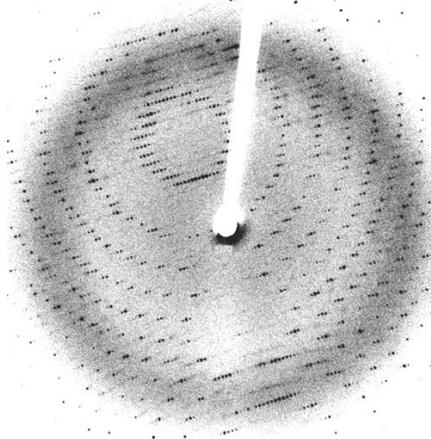
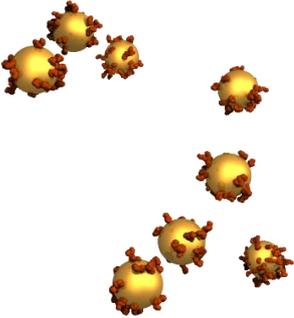
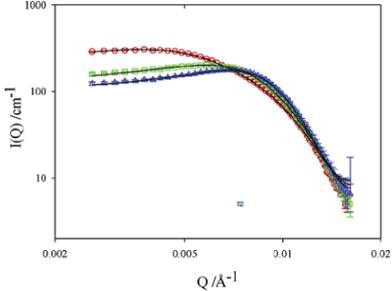
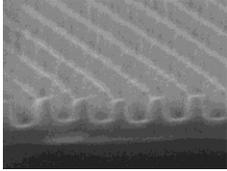
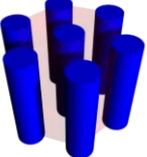
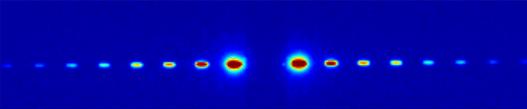
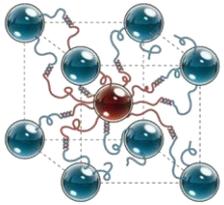
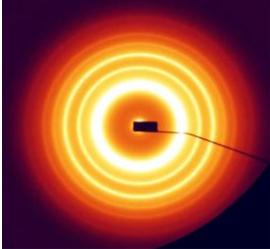
- Interference of scattered waves produces distinct spots or rings at angles that encode structural information

$$n\lambda = 2d \sin \theta$$



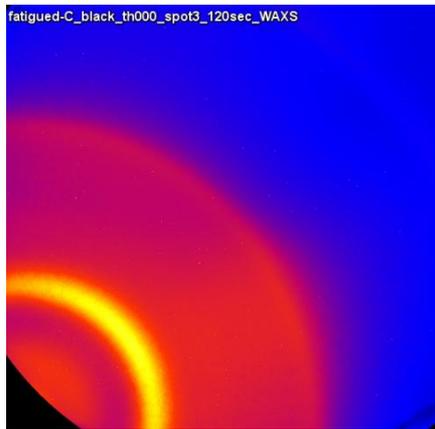
- Wide-angles: atomic/molecular
- Small-angles: nano

## Organization of constituents ("Structure Factor")

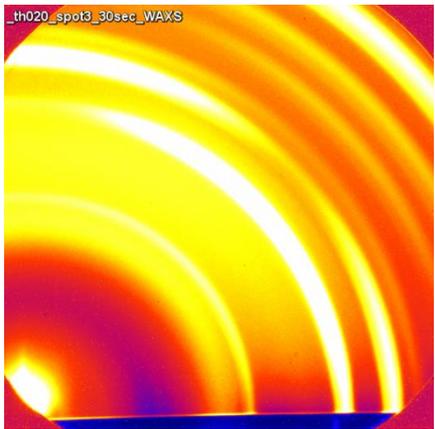
|                              |           | Organization of constituents ("Structure Factor")   |   |
|------------------------------|-----------|---|---|
|                              |           | Random  | Periodic  |
| Constituents ("Form Factor") | Simple    | <p>Gases, liquids, glasses, ...</p>              | <p>Crystals, ...</p>    |
|                              | Arbitrary | <p>Colloids, proteins in solution, ...</p>   | <p>Lithography, nano-particle lattices, ...</p>      |

# X-ray Scattering

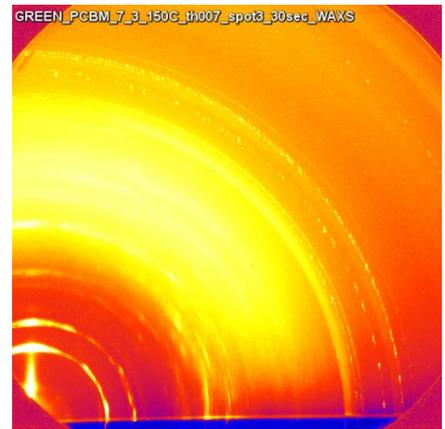
- Qualitative: assess order
- Peak positions: quantify  $d$ -spacing
  - Multiple peaks: determine symmetry, solve for unit cell
- Peak width: calculate grain size
- Intensity: quantify amounts of populations
- Intensity along arcs: determine orientation distribution



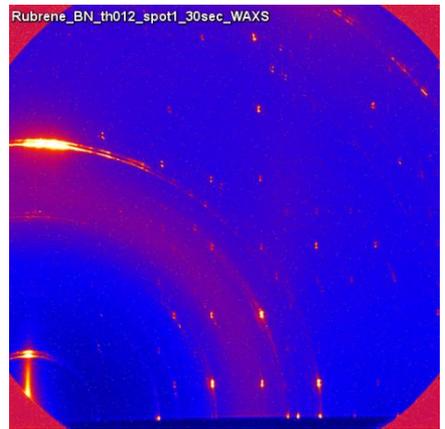
disordered



some ordering



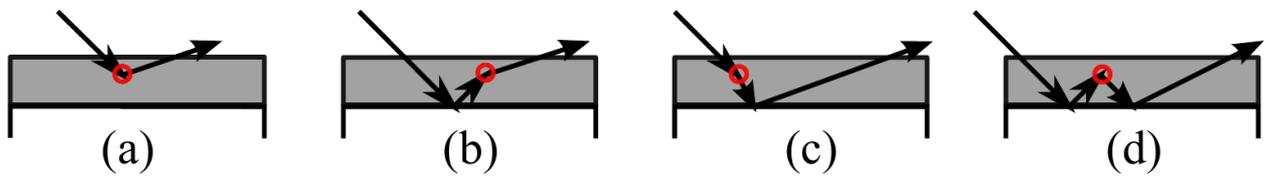
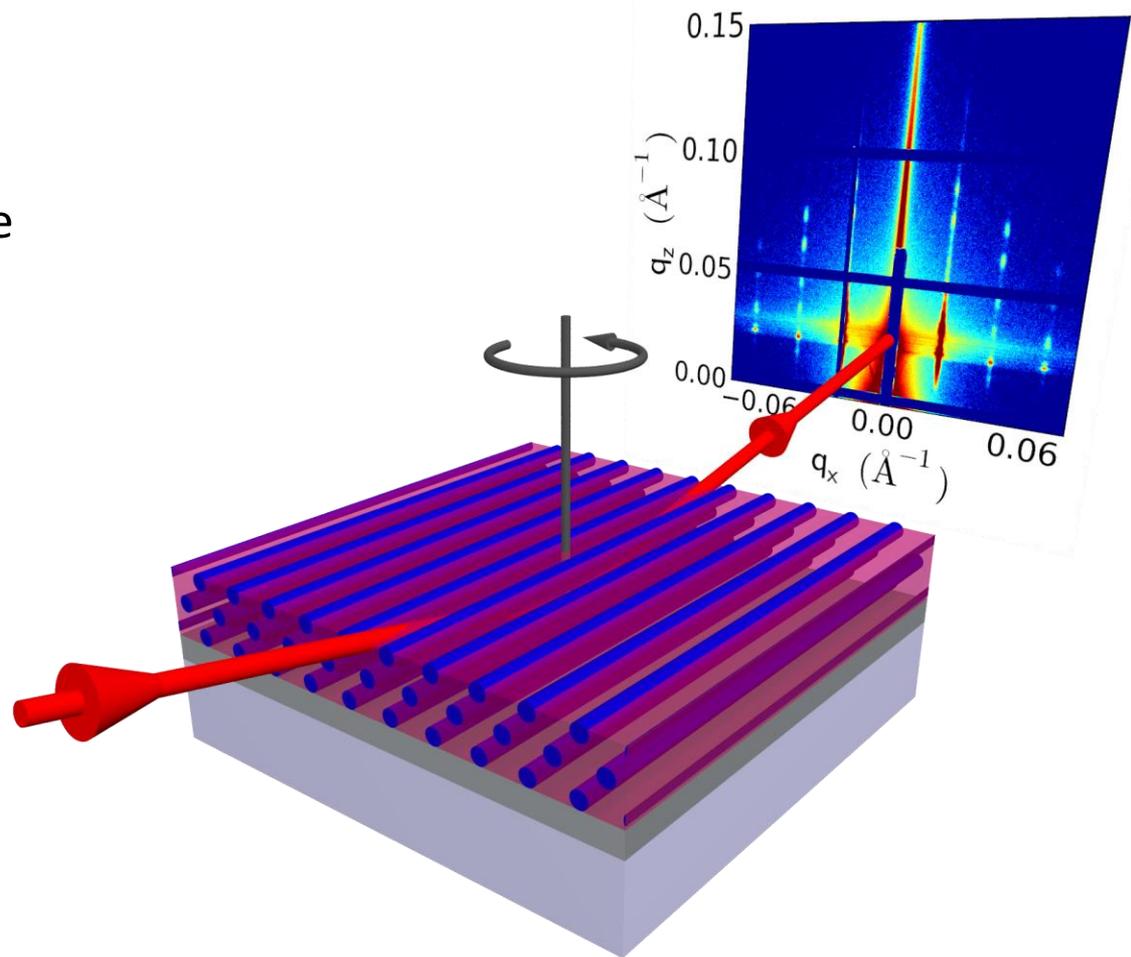
oriented, textured



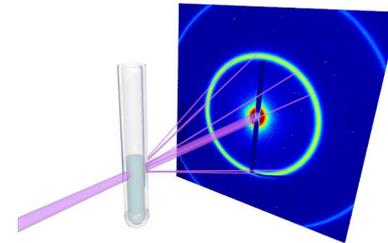
single crystal



- **Grazing-Incidence Small-Angle X-ray Scattering**
- Strong signal:
  - Beam projection on sample
  - Reflection-mode enhances E-field in film
- In-plane and out-of-plane structure
- Analysis complicated:
  - Refraction and reflection shifts  $q$ -space
  - Data is sum of many possible reflection/scattering terms

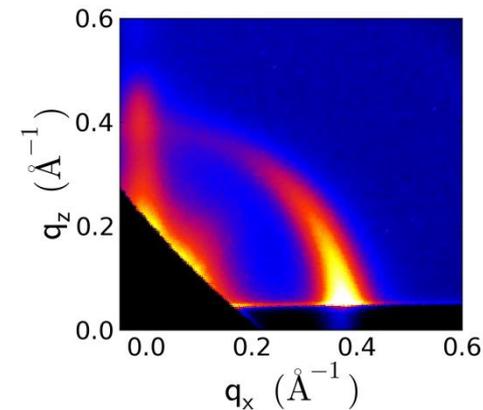


- X-ray scattering for nanoscience



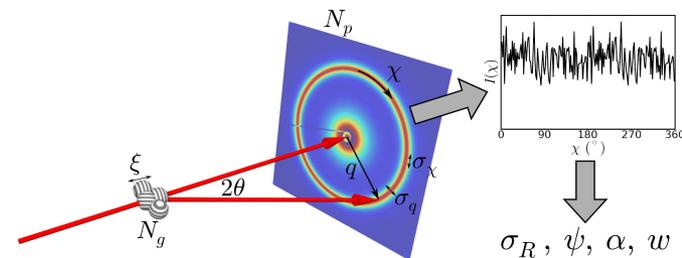
- Experimental examples:

- P3HT
- Block-copolymers
- 2D nanoparticle assembly

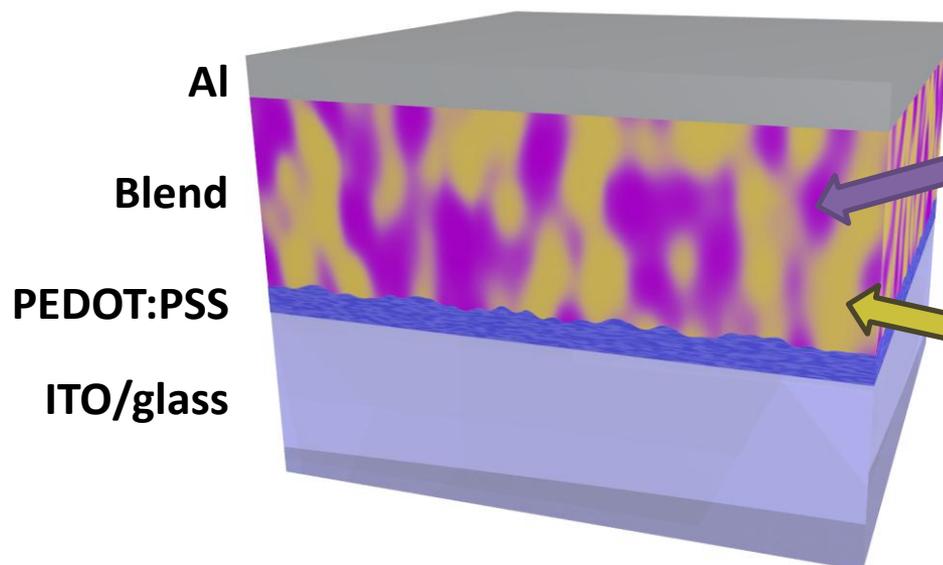


- New techniques:

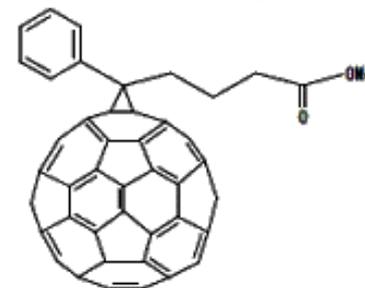
- Variance scattering
- GTSAXS
- Nano-lattice model



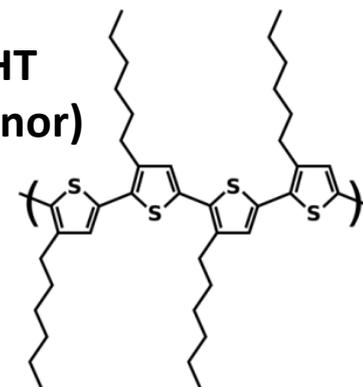
- Prototypical OPV: P3HT/PCBM bulk-heterojunction



**PCBM (acceptor)**

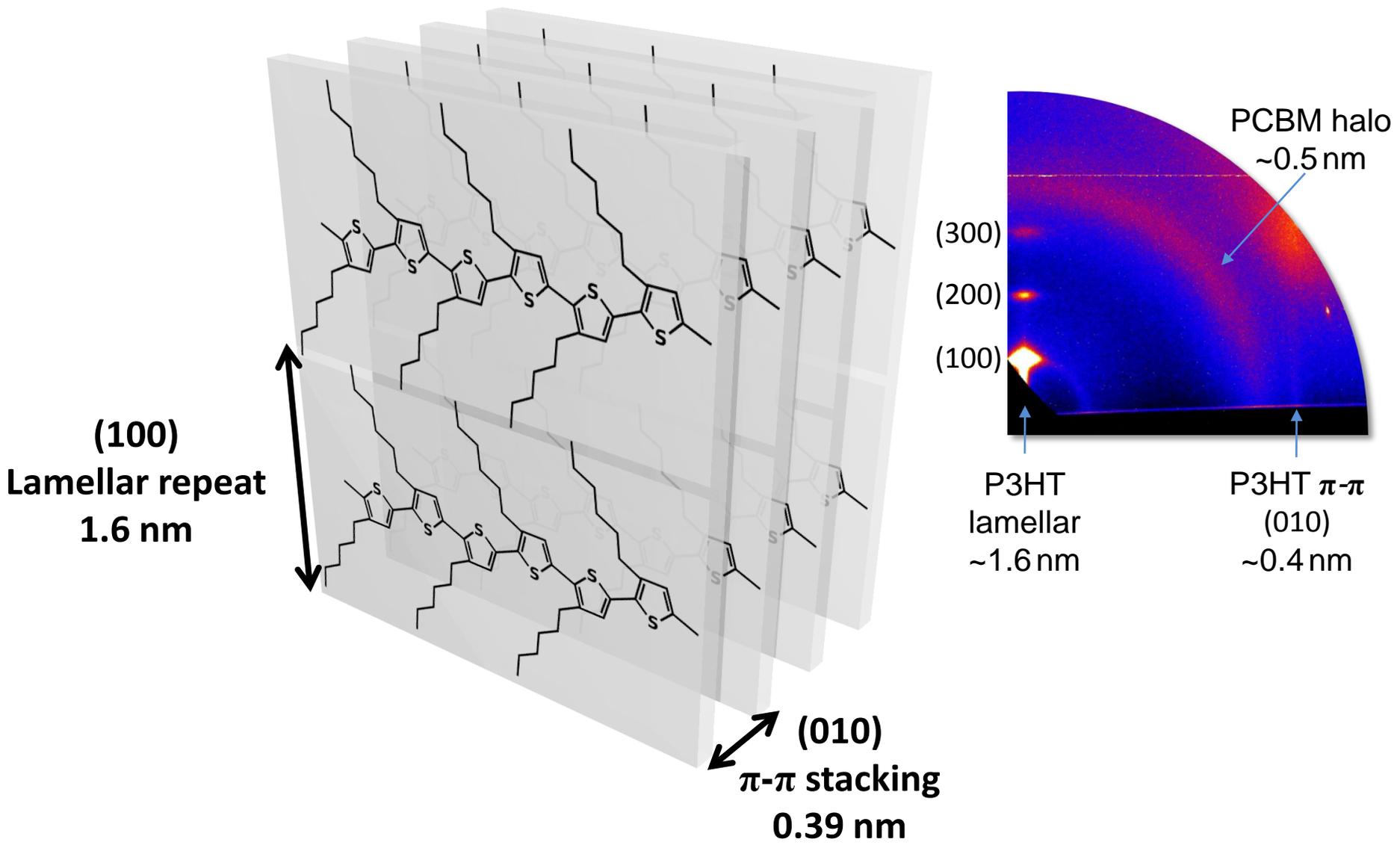


**P3HT (donor)**



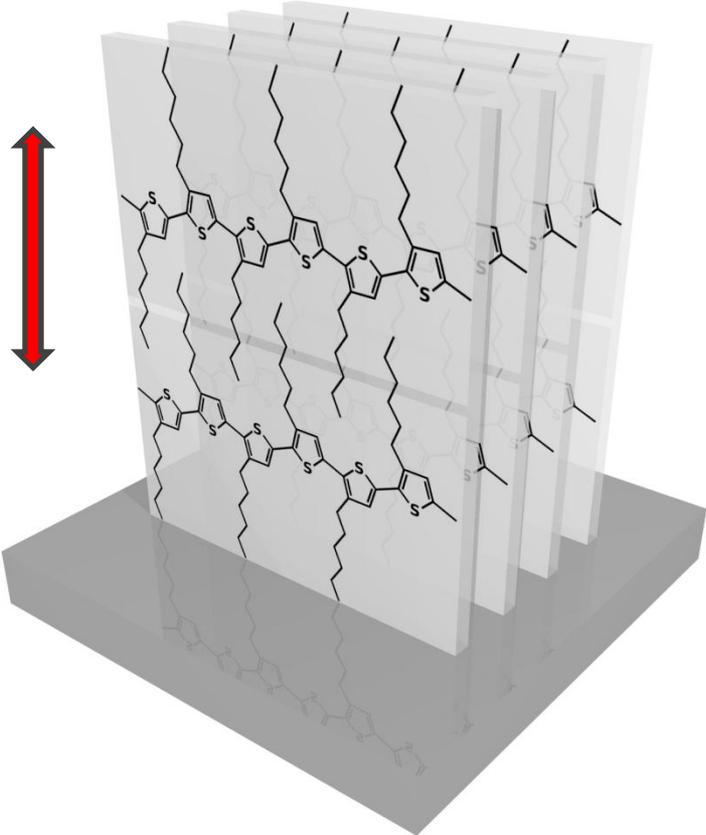
- Exciton diffusion length  $\approx$  10-20 nm
- Film thickness  $\approx$  100 nm
- Need network for charge transport, but small domains to avoid recombination
- Ideal morphology is actually trapped in a non-equilibrium state (control and stability issues!)

# P3HT: poly 3-hexylthiophene



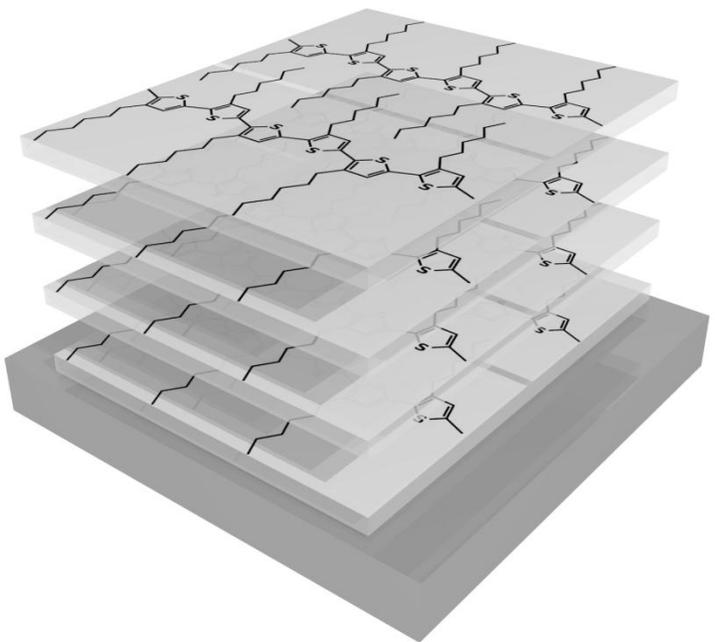
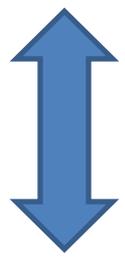
# Anisotropic Conduction

- Face-on orientation would be ~300× better



**Edge-on**

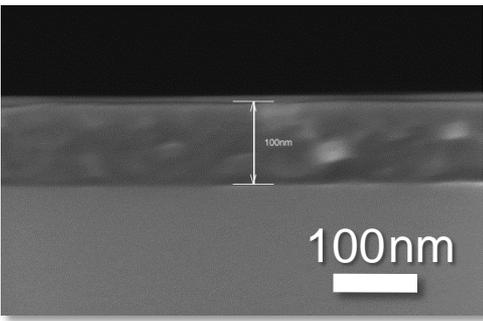
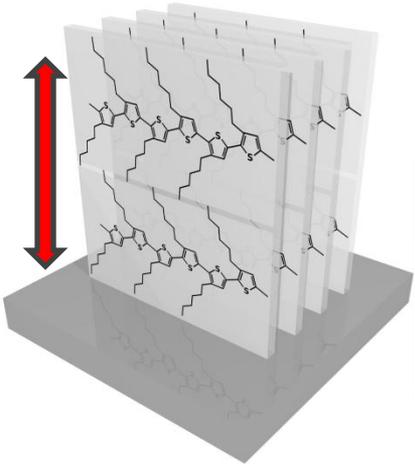
$\alpha_h \approx 0.0002 \text{ cm}^2\text{V}^{-1}\text{s}^{-1}$



**Face-on**

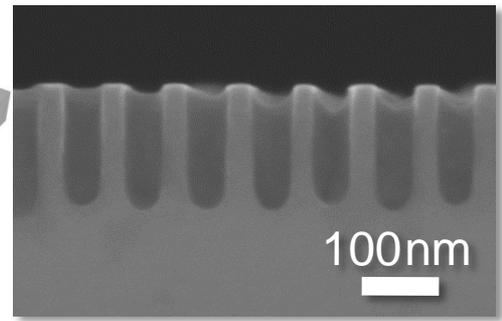
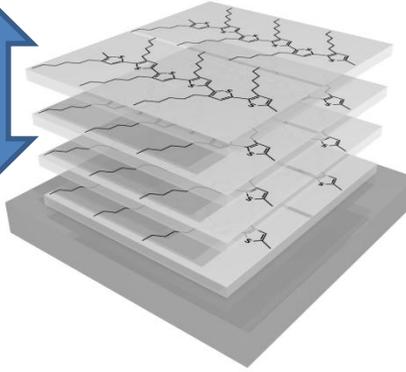
$\alpha_h \approx 0.1 \text{ cm}^2\text{V}^{-1}\text{s}^{-1}$

# P3HT Orientation



**Edge-on**

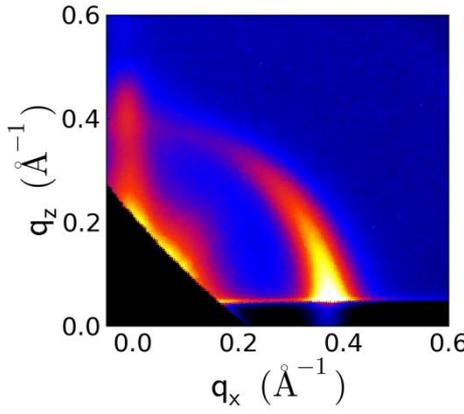
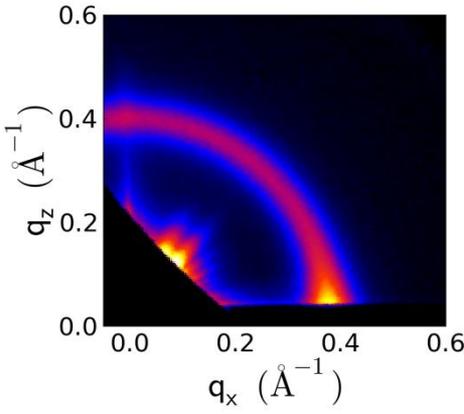
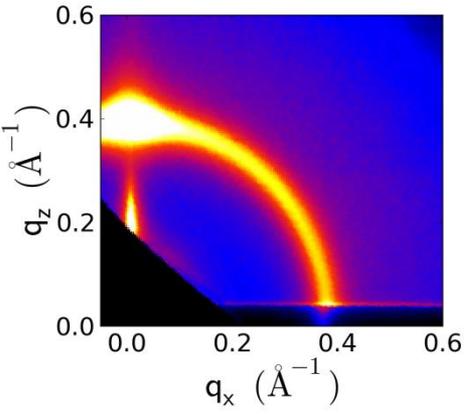
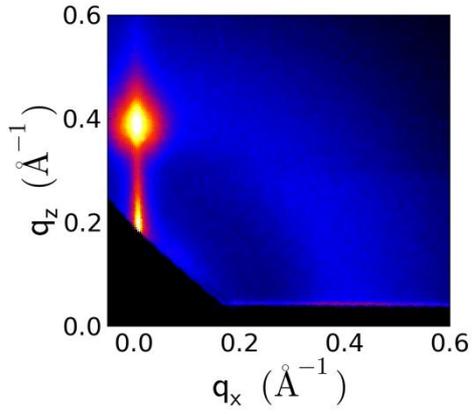
$$\alpha_h \approx 0.0002 \text{ cm}^2\text{V}^{-1}\text{s}^{-1}$$



**Face-on**

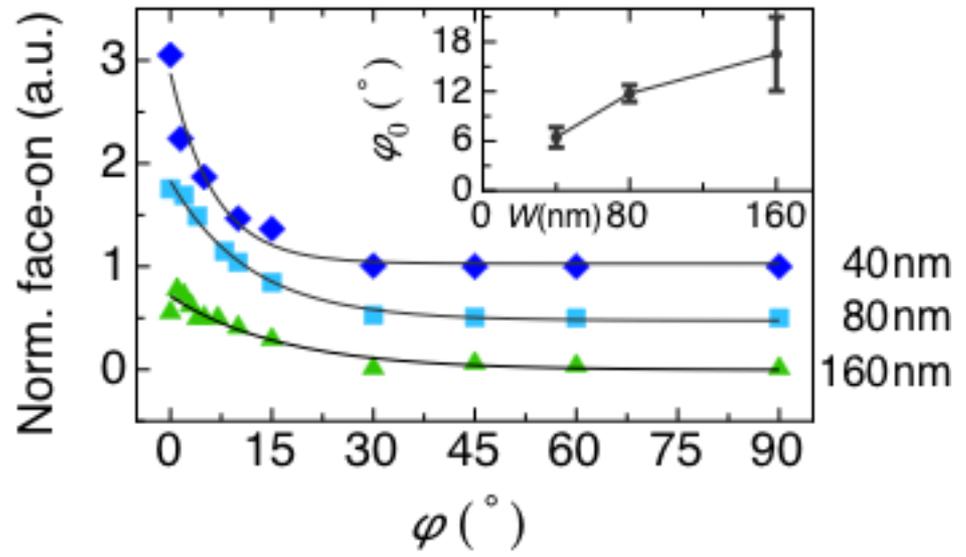
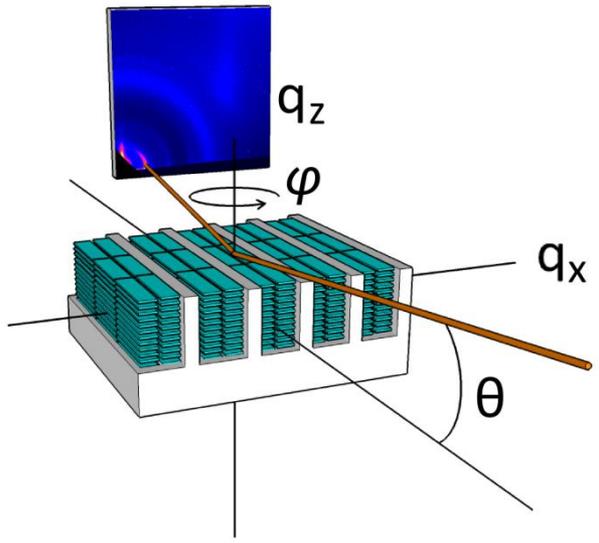
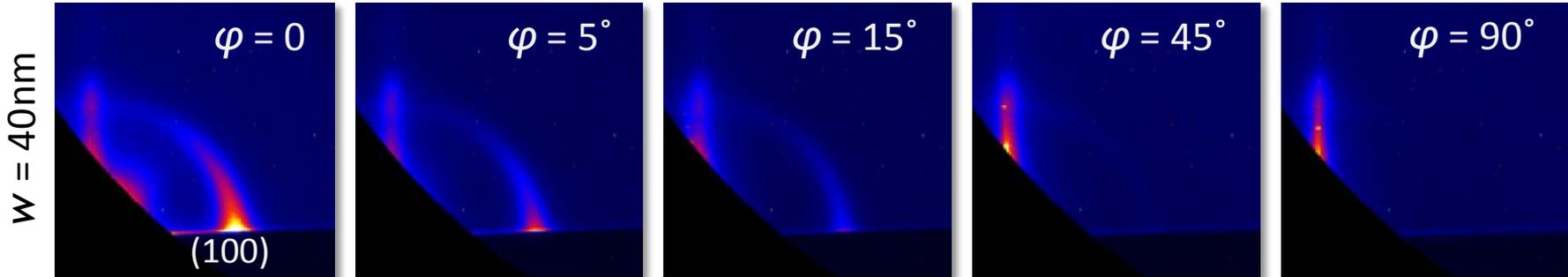
$$\alpha_h \approx 0.1 \text{ cm}^2\text{V}^{-1}\text{s}^{-1}$$

- Intensity along ring tells orientation



# In-plane Alignment

- Chains align with the grooves
- Not an in-plane powder!



# Block copolymers

**A** in **B** matrix

**B** in **A** matrix

cubic  
spheres

hexagonal  
cylinders

bicontinuous  
gyroid

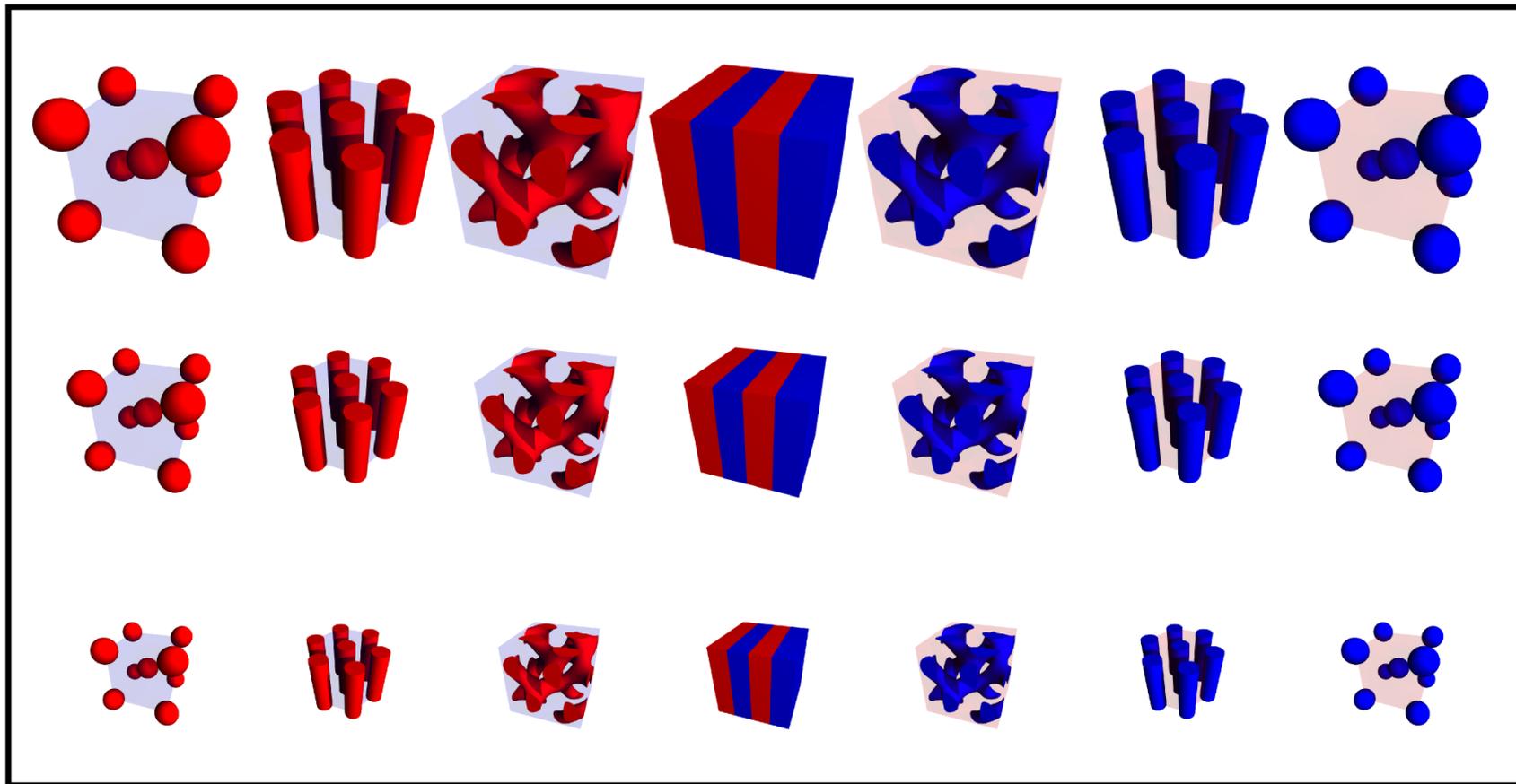
lamellae

bicontinuous  
gyroid

hexagonal  
cylinders

cubic  
spheres

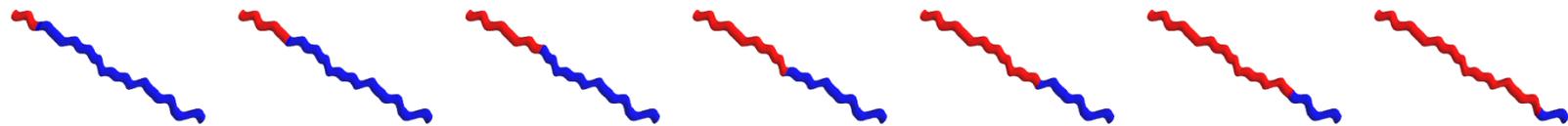
Chain length



bigger  
structures

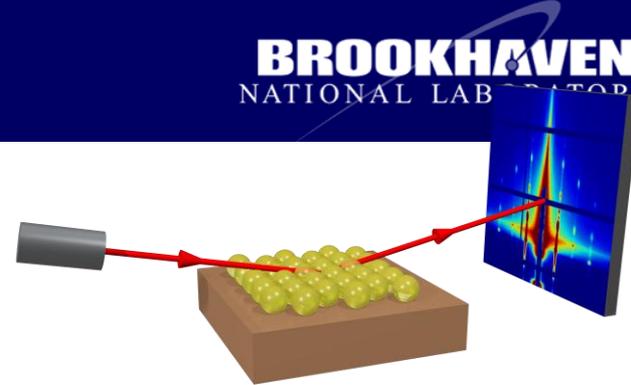
smaller  
structures

Chain makeup

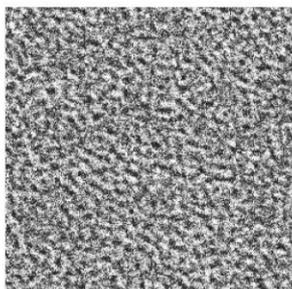
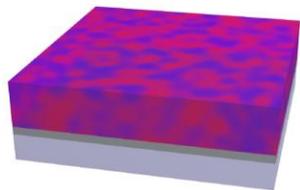


# GISAXS of BCP

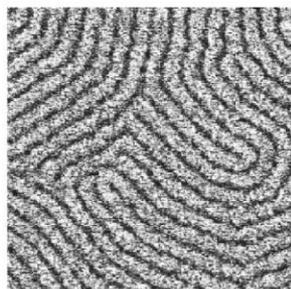
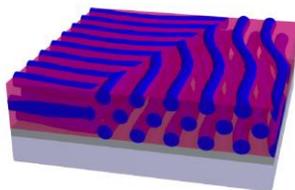
- Determine morphology, grain size, orientation, ...



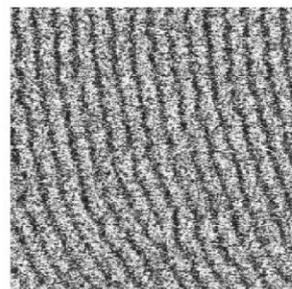
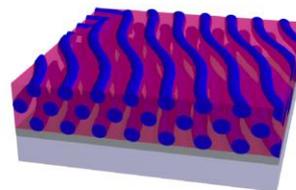
**disordered**



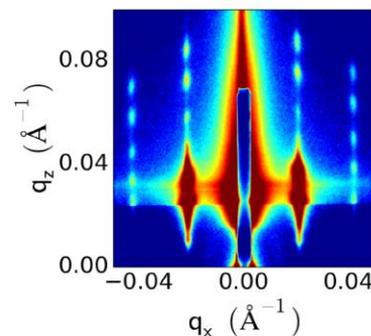
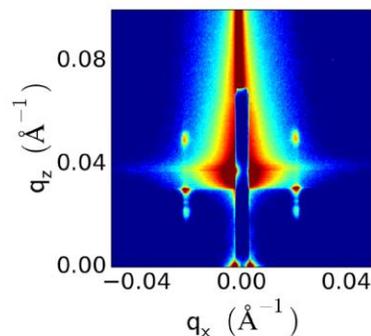
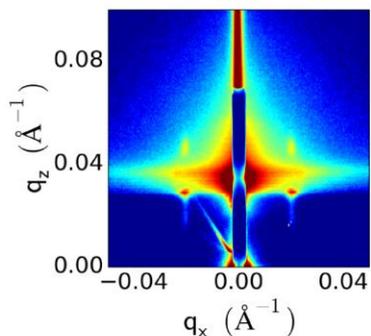
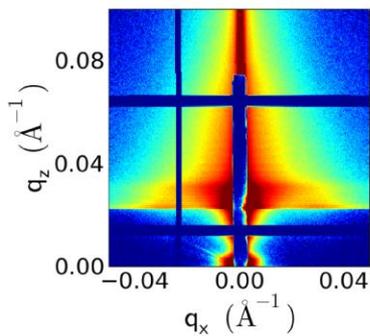
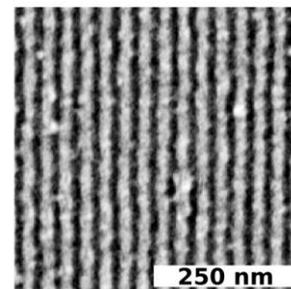
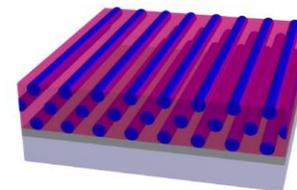
**ordered**



**large grains**

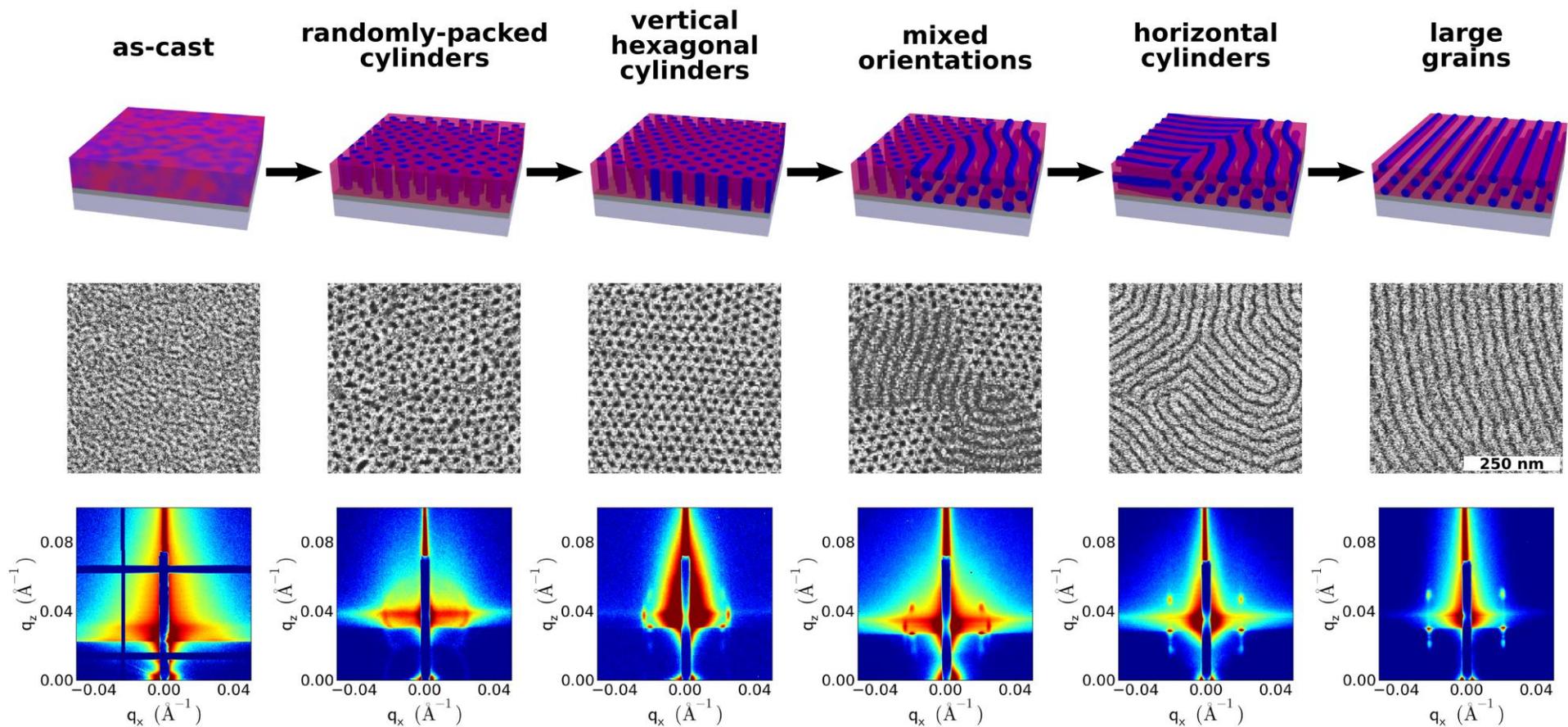


**excellent order**

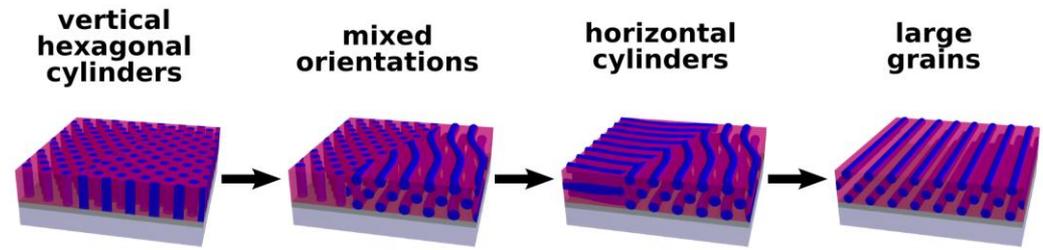
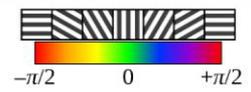
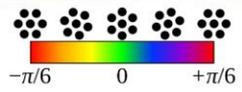
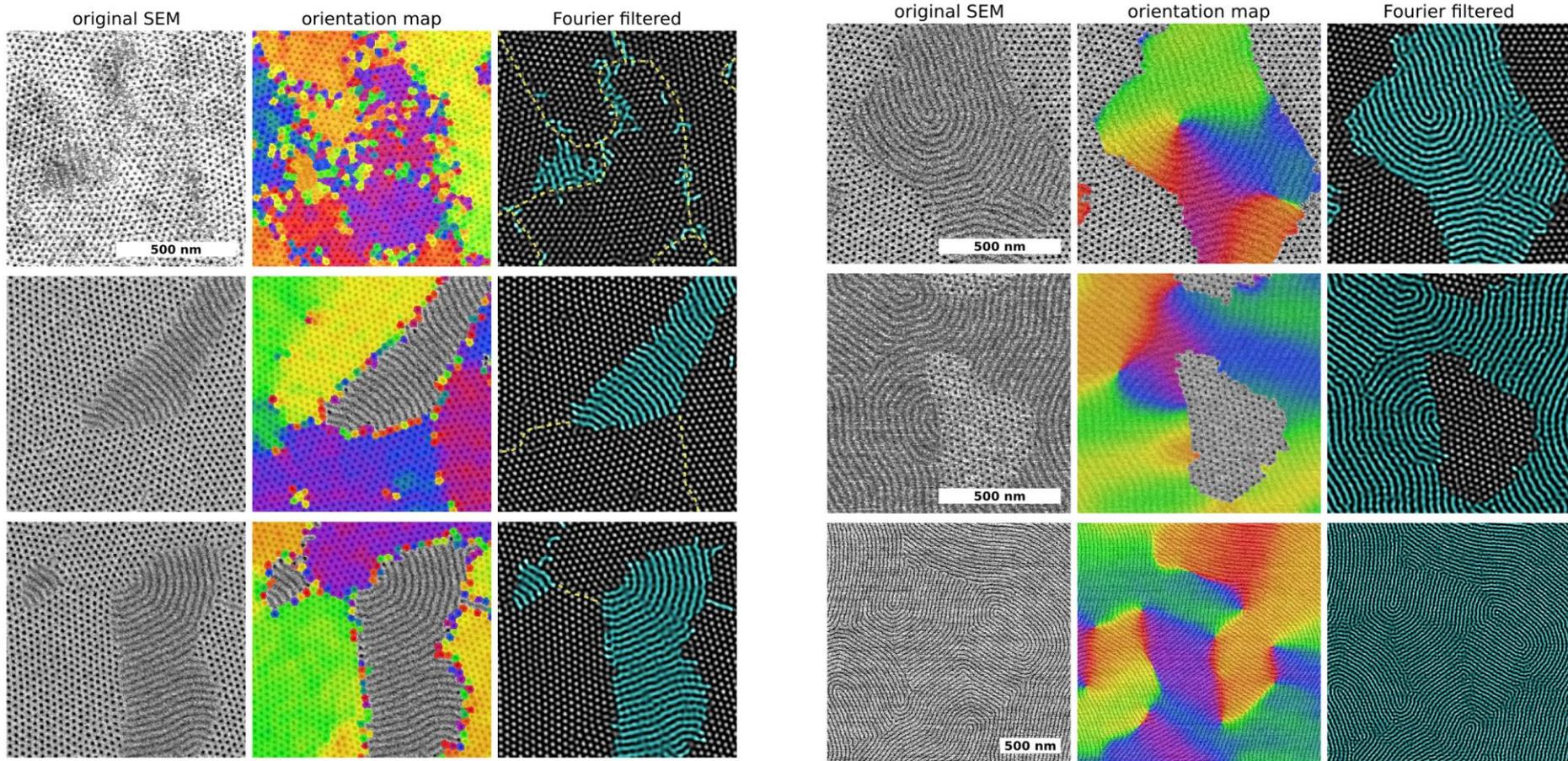


# Reordering Transitions

- Transient states may appear during assembly



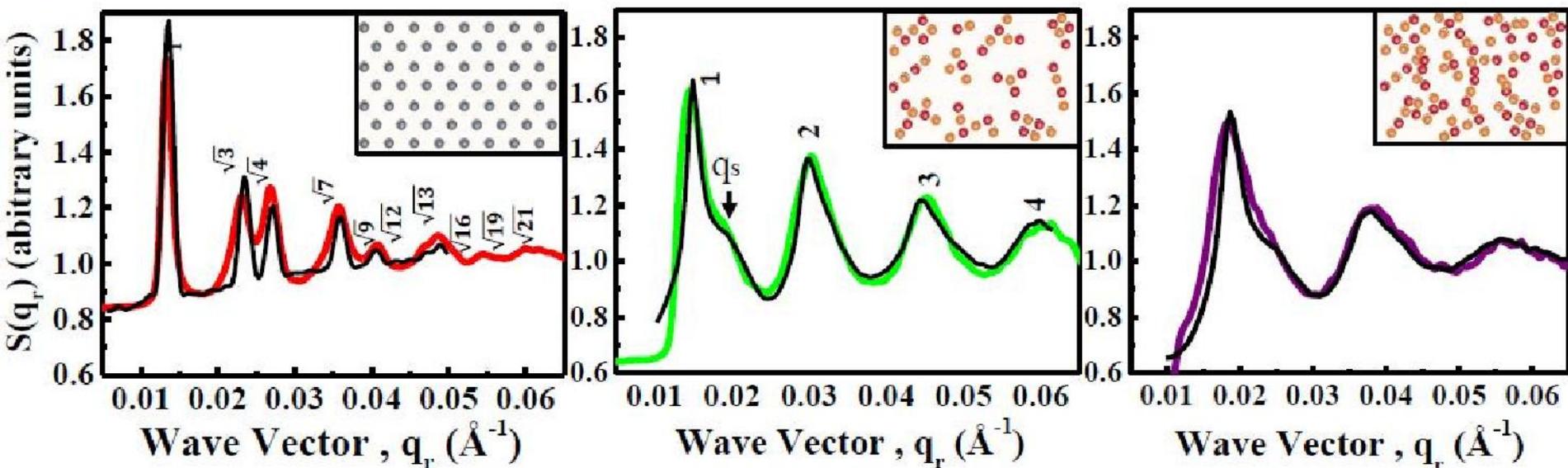
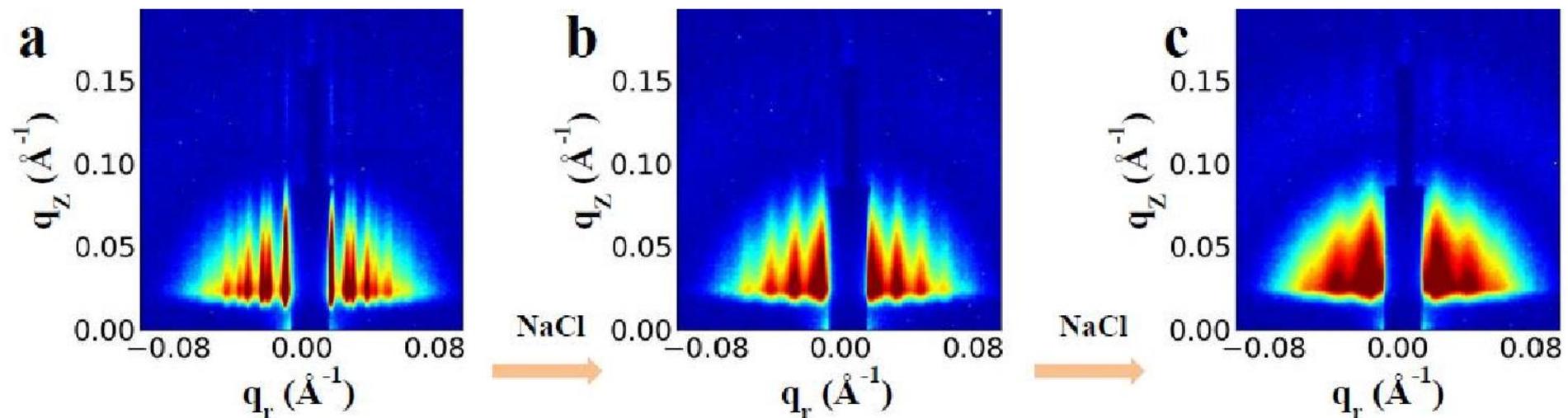
# Reorientation Transition



# 2-D Nanoparticle Assembly

- Nanoparticles attracted to air-water (due to charge)
- Nanoparticle organization controlled by DNA coronas

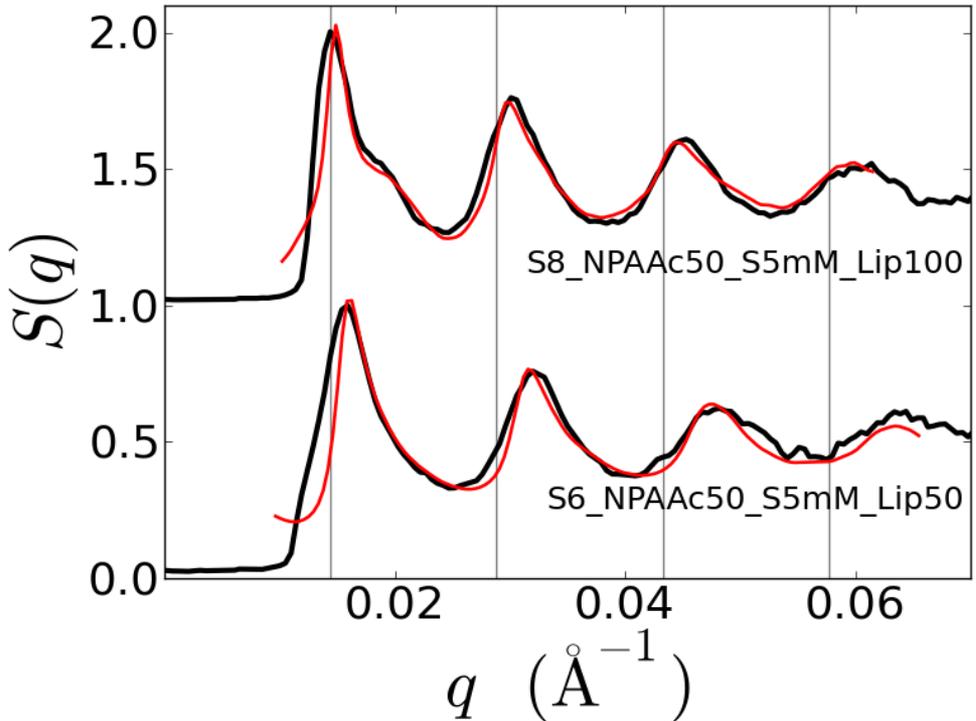
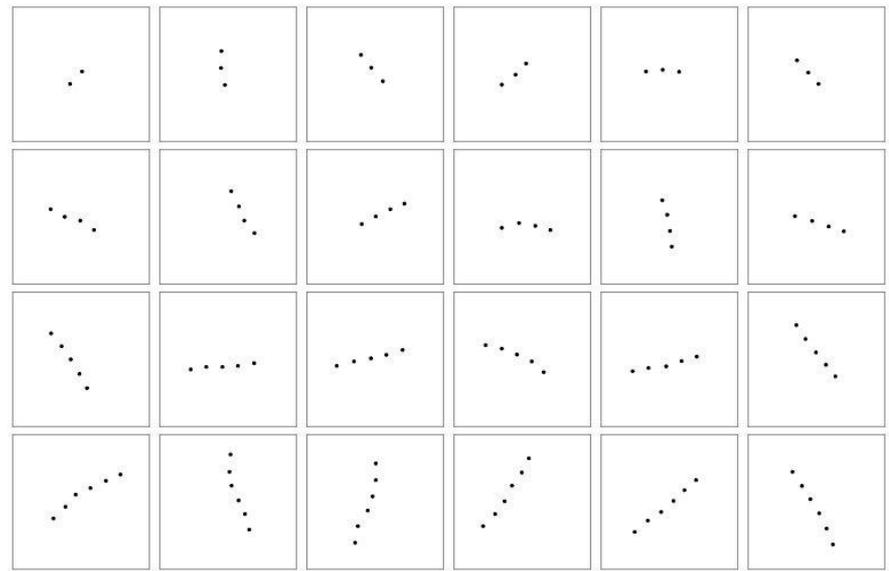
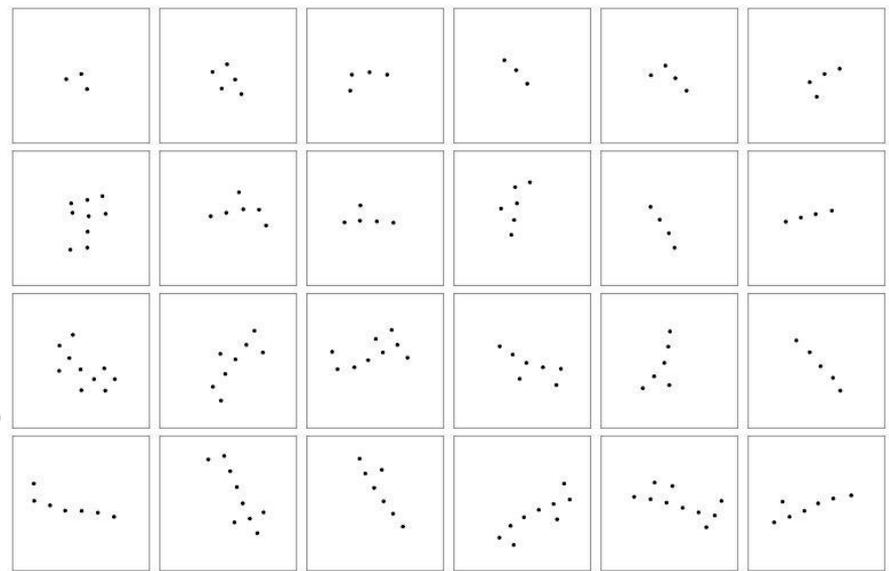
Srivastava *JACS* 2014



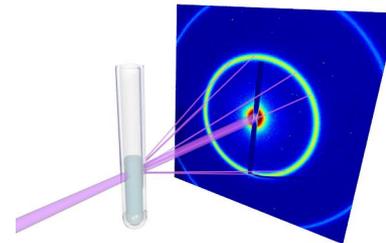
# 2-D Nanoparticle Assembly

- Brute-force modeling...

$$\begin{aligned}
 P(q_r) &= \int_0^{2\pi} |F(q_x, q_y)|^2 d\phi \\
 &= \int_0^{2\pi} |\rho(r) e^{iq \cdot r} dV|^2 d\phi \\
 &= \int_0^{2\pi} \left| \int_{-\infty}^{+\infty} \int_{-\infty}^{+\infty} \rho(x, y) e^{iq_x x} e^{iq_y y} dx dy \right|^2 d\phi \\
 &= \int_0^{2\pi} \left| \int_{-\infty}^{+\infty} \int_{-\infty}^{+\infty} \rho(x, y) e^{iq_r \sin(\phi)x} e^{iq_r \cos(\phi)y} dx dy \right|^2 d\phi
 \end{aligned}$$

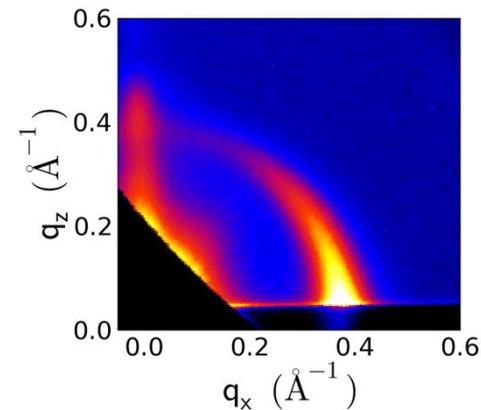


- X-ray scattering for nanoscience



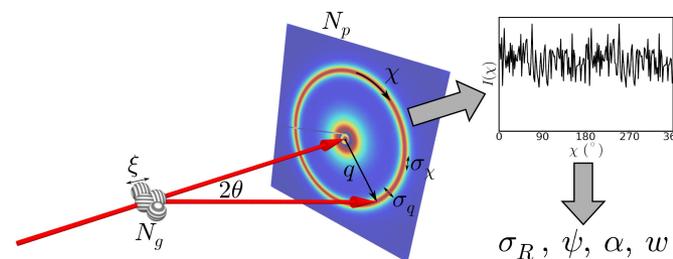
- Experimental examples:

- P3HT
- Block-copolymers
- 2D nanoparticle assembly



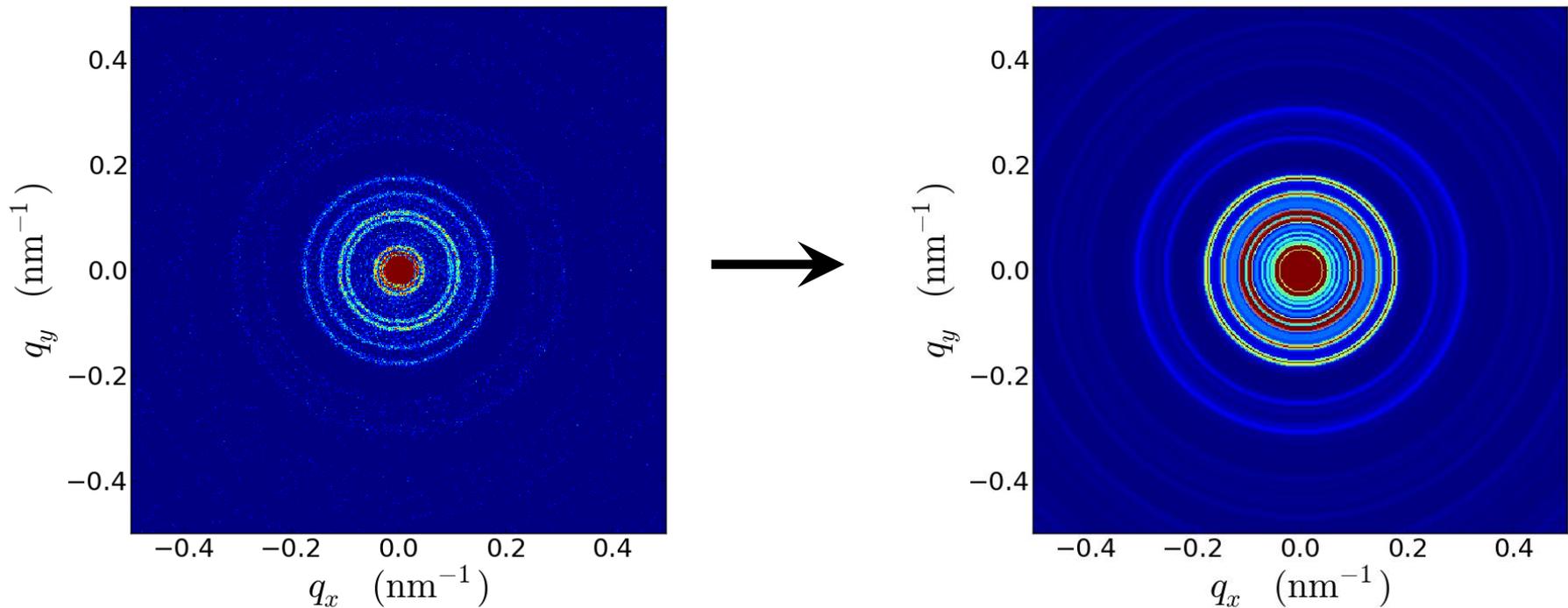
- New techniques:

- Variance scattering
- GTSAXS
- Nano-lattice model



# 'Variance Scattering'

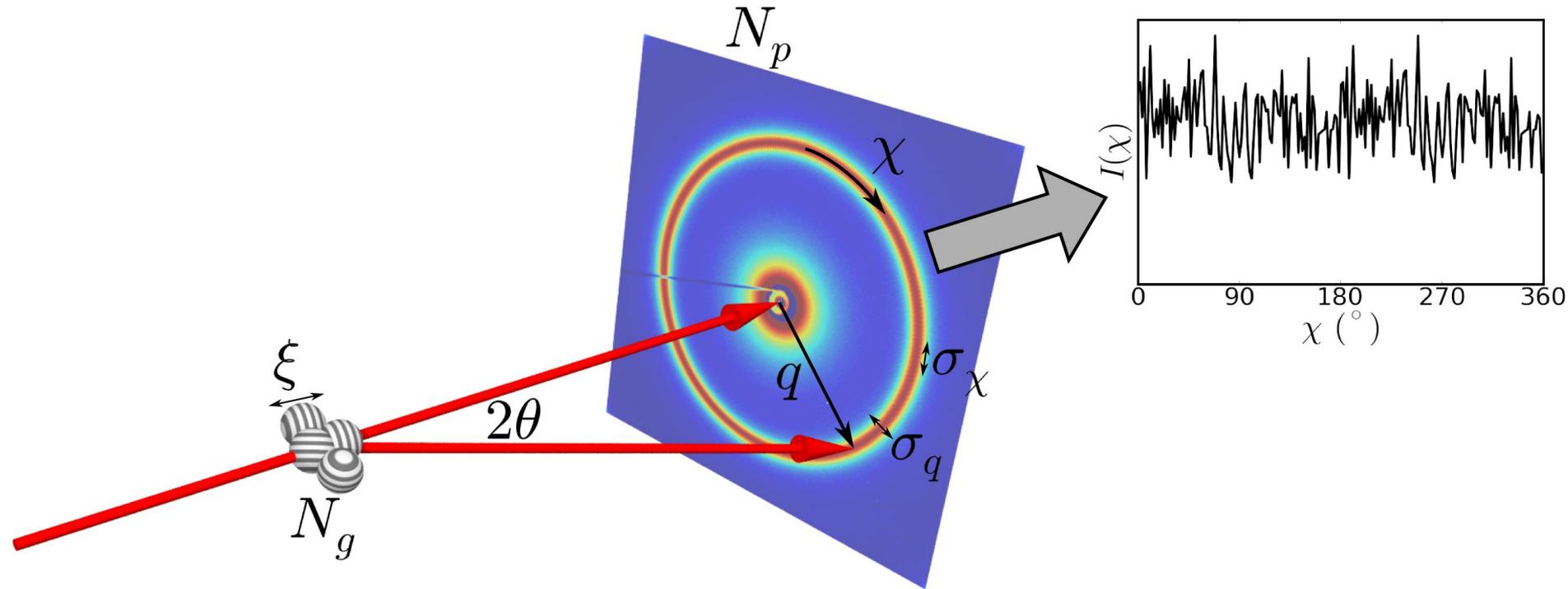
- Conventionally, when we measure a scattering pattern, we accumulate data over a large area and time, to average-out random fluctuations...



- What if, instead of ignoring those variations, you **emphasize** them, and **monitor** them?

# Scattering Ring

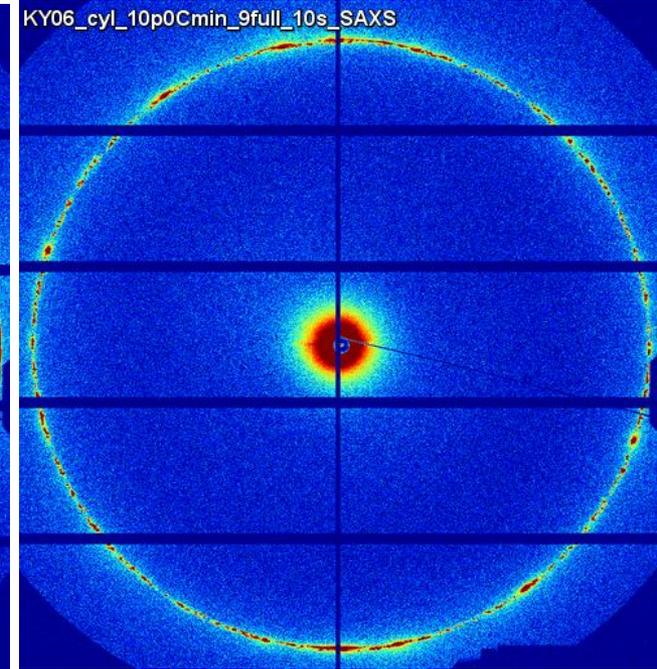
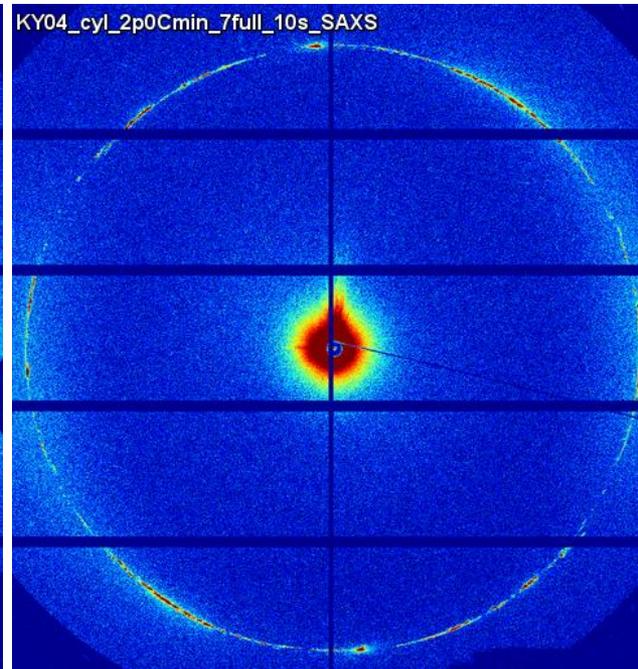
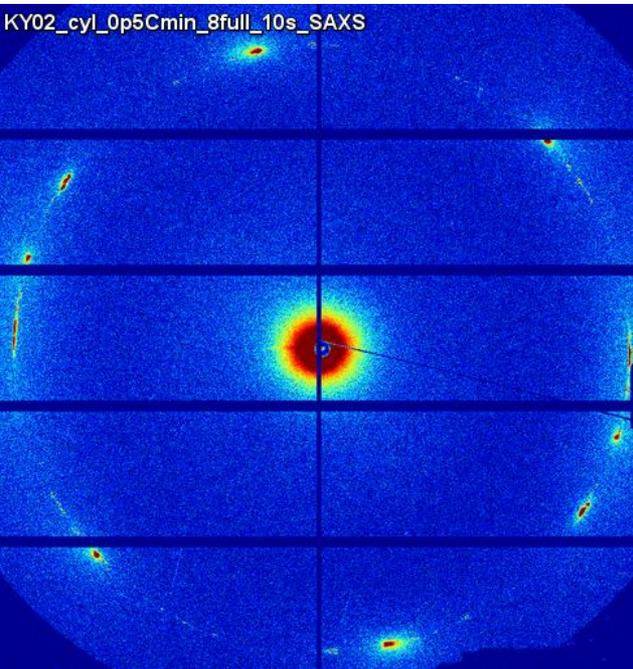
- A scattering ring is a summation of many peaks
- Each set of  $m$  peaks comes from a different grain in the sample



- The more grains probed by the beam, the more uniform the ring becomes

# Scattering Ring

- The more grains probed by the beam, the more uniform the ring becomes
- The detector probes only a fraction of the peaks in reciprocal-space

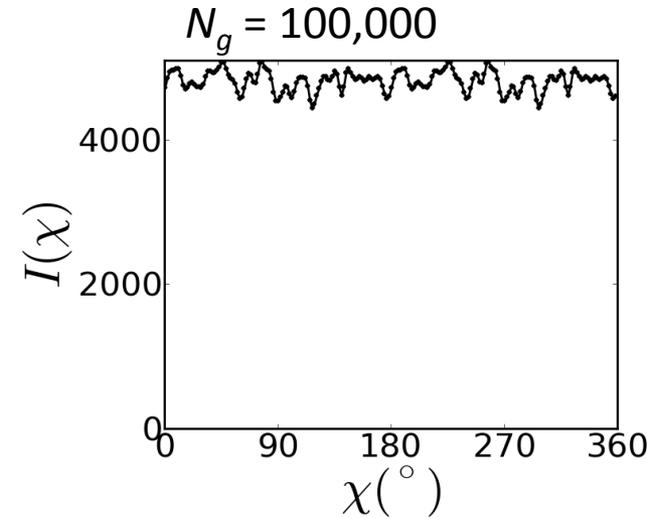
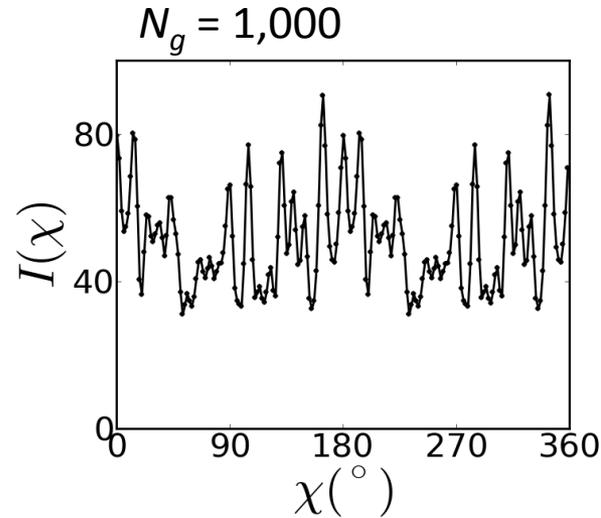
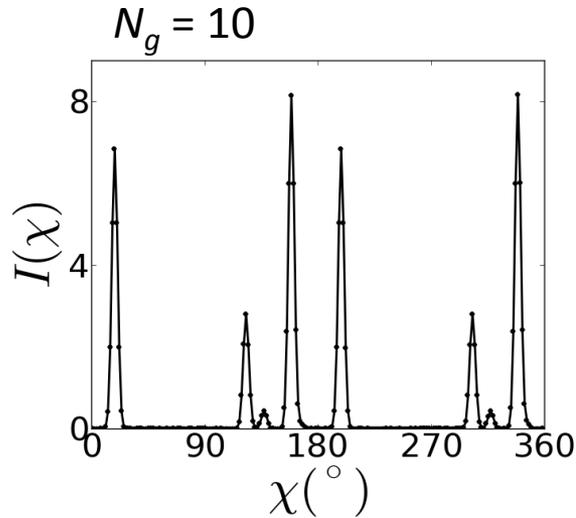


$$\begin{aligned} f_{\text{Ewald}} &= \frac{\pi 2q \times (\sqrt{2\pi}\sigma_q) \times (\sqrt{2\pi}\sigma_q)}{4\pi q^2 \times (\sqrt{2\pi}\sigma_q)} \\ &= \frac{\sqrt{2\pi}\sigma_q}{2q} \end{aligned}$$

$$\begin{aligned} N_p &= m f_{\text{Ewald}} f_{\chi} N_g \\ &= \frac{m \sqrt{2\pi}\sigma_q f_{\chi}}{2q} N_g \\ N_g &= \frac{2q}{m \sqrt{2\pi}\sigma_q f_{\chi}} N_p \end{aligned}$$

# Ring Graininess

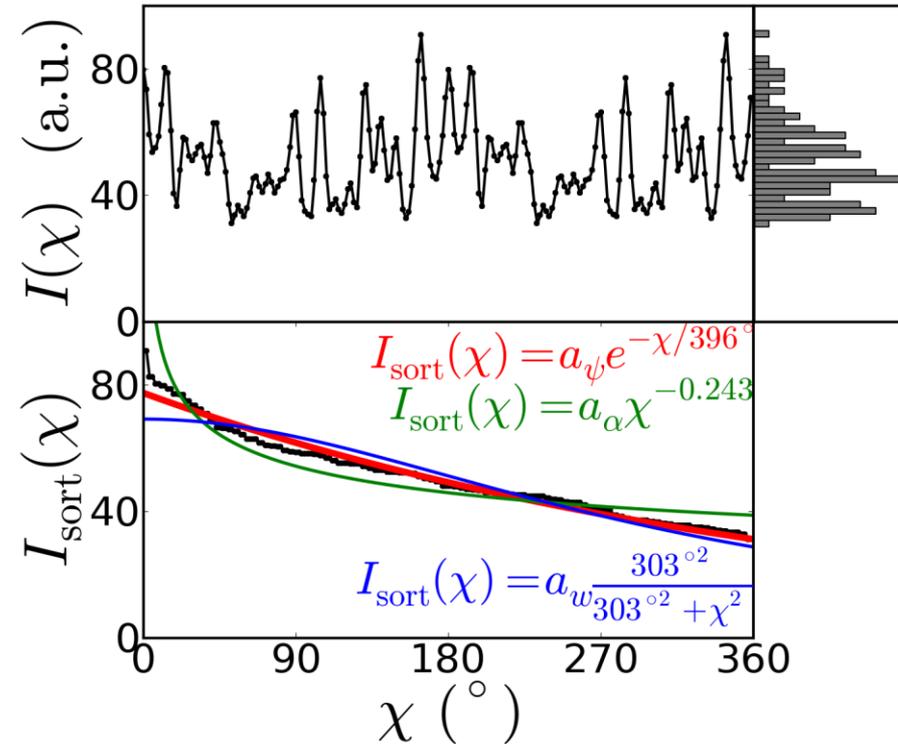
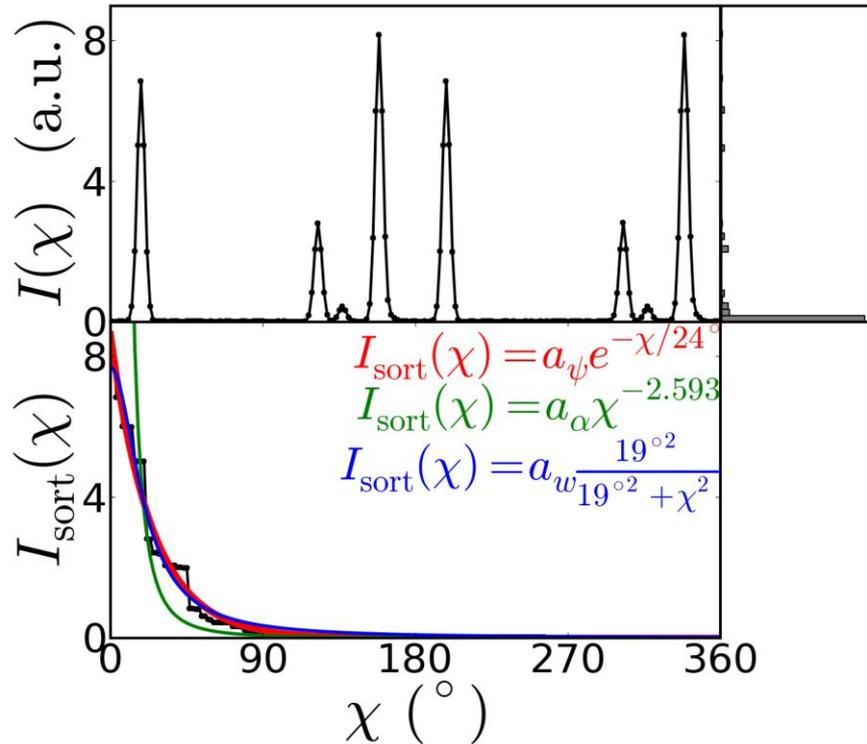
- Simulations are used to generate scattering rings for different number of grains ( $N_g$ )



- We can quantify the variation...

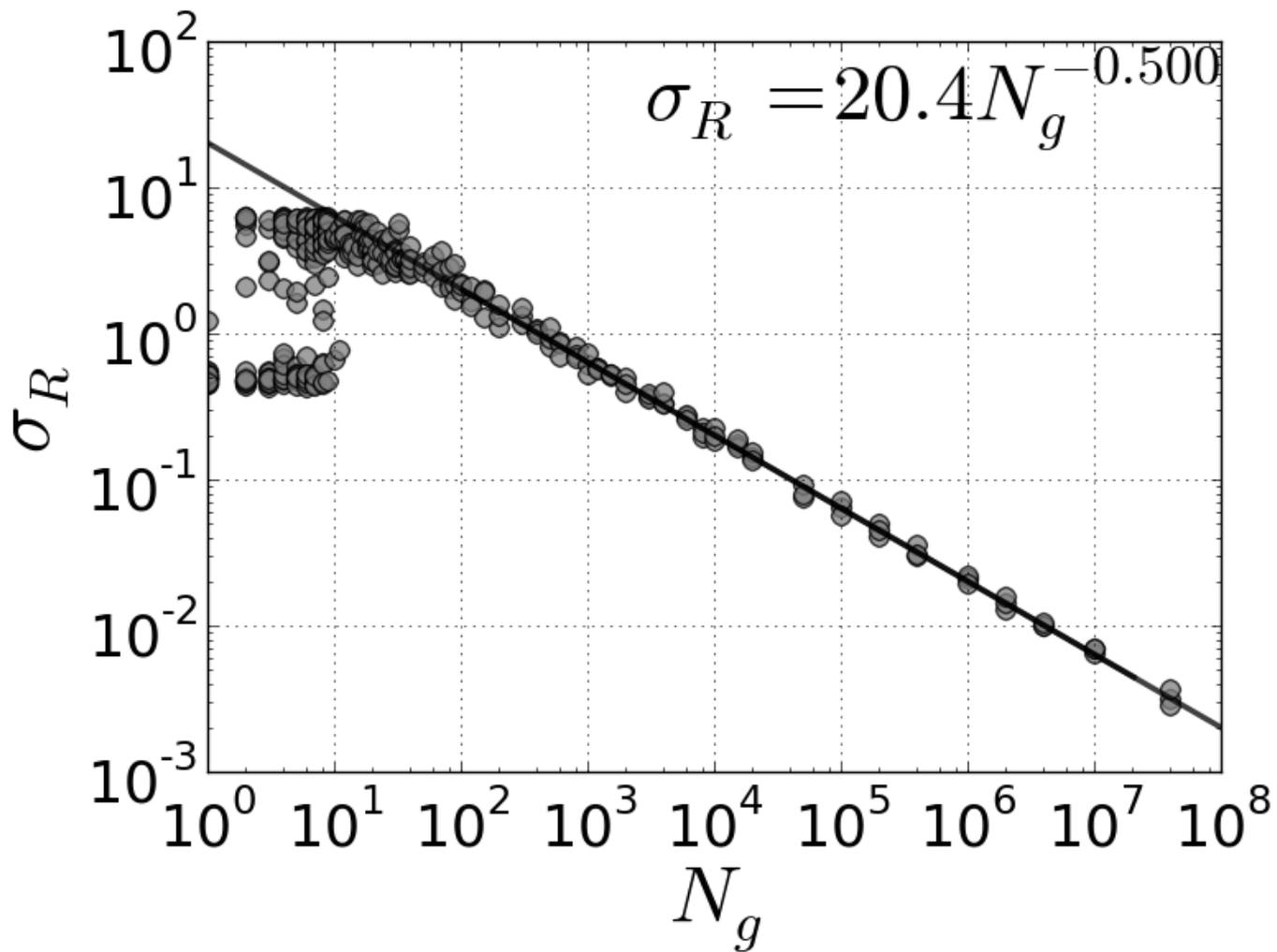
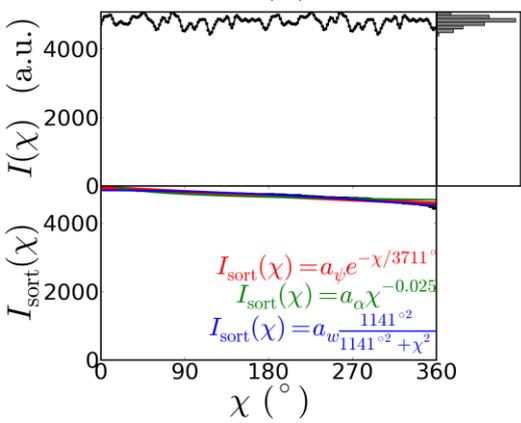
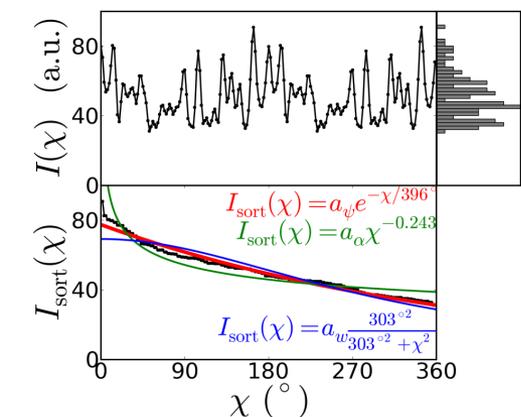
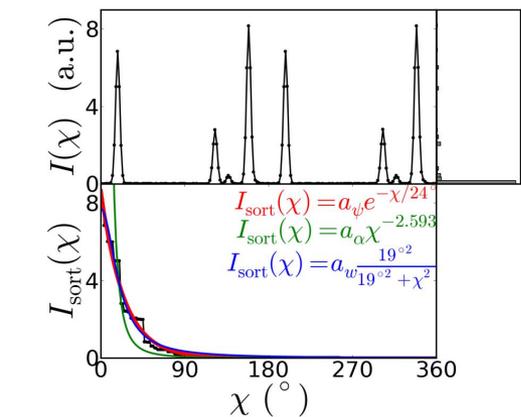
# Ring Graininess

- One simple metric is the relative **standard deviation** of the intensity

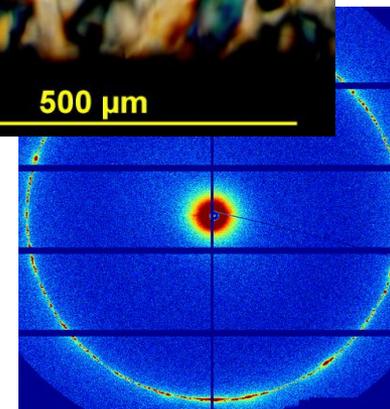
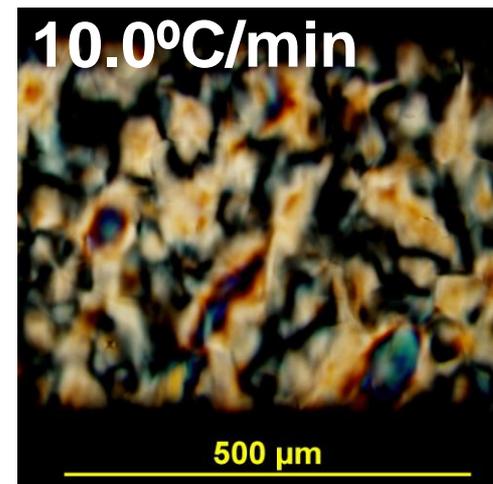
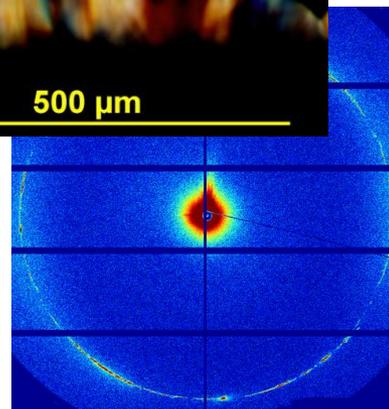
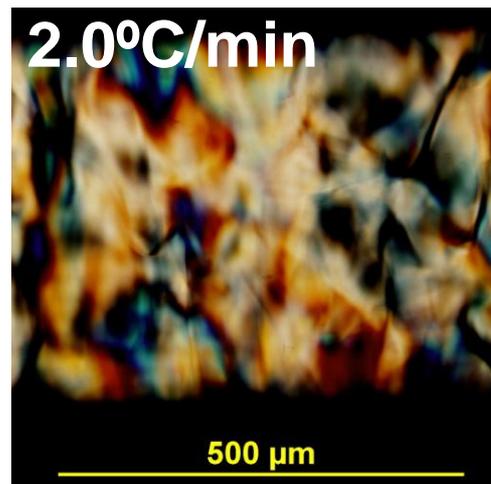
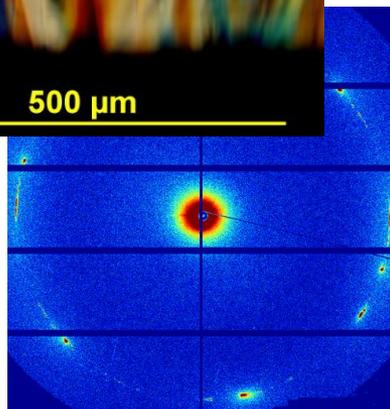
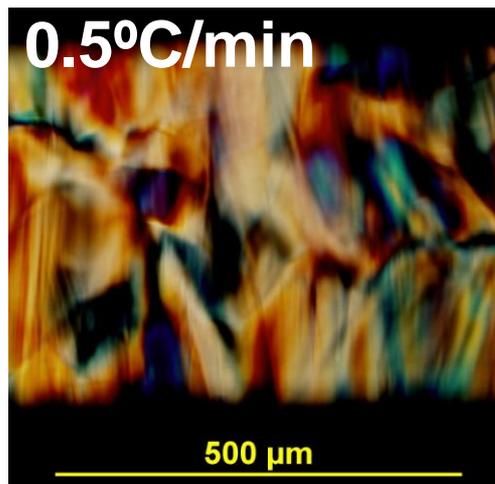


- The decay of the “sorted” curve also encodes how many peaks were in the signal
- We can fit the decay of the “sorted” curve

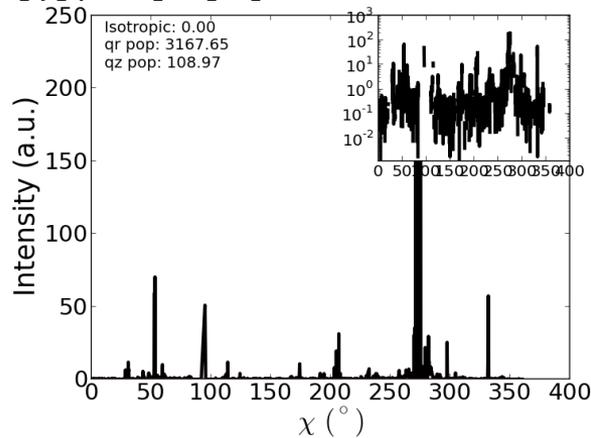
# $\sigma_R$ metric



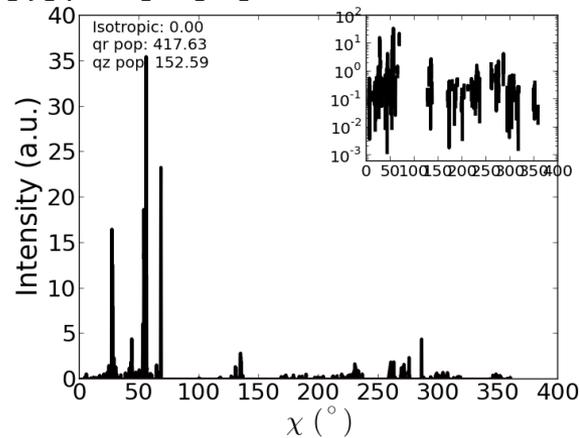
# Experimental: liquid crystal



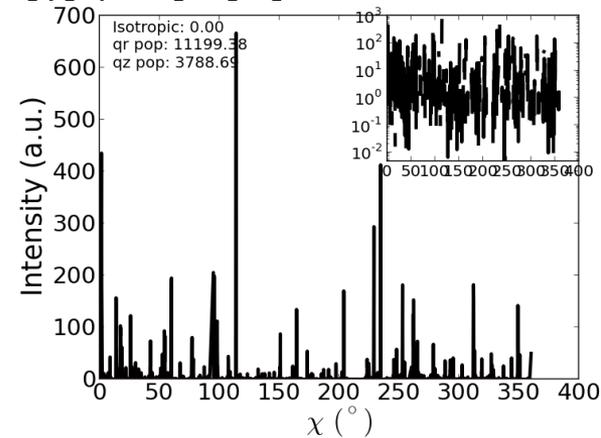
KY02\_cyl\_0p5Cmin\_6full\_10s\_SAXS-linecut



KY04\_cyl\_2p0Cmin\_5full\_10s\_SAXS-linecut



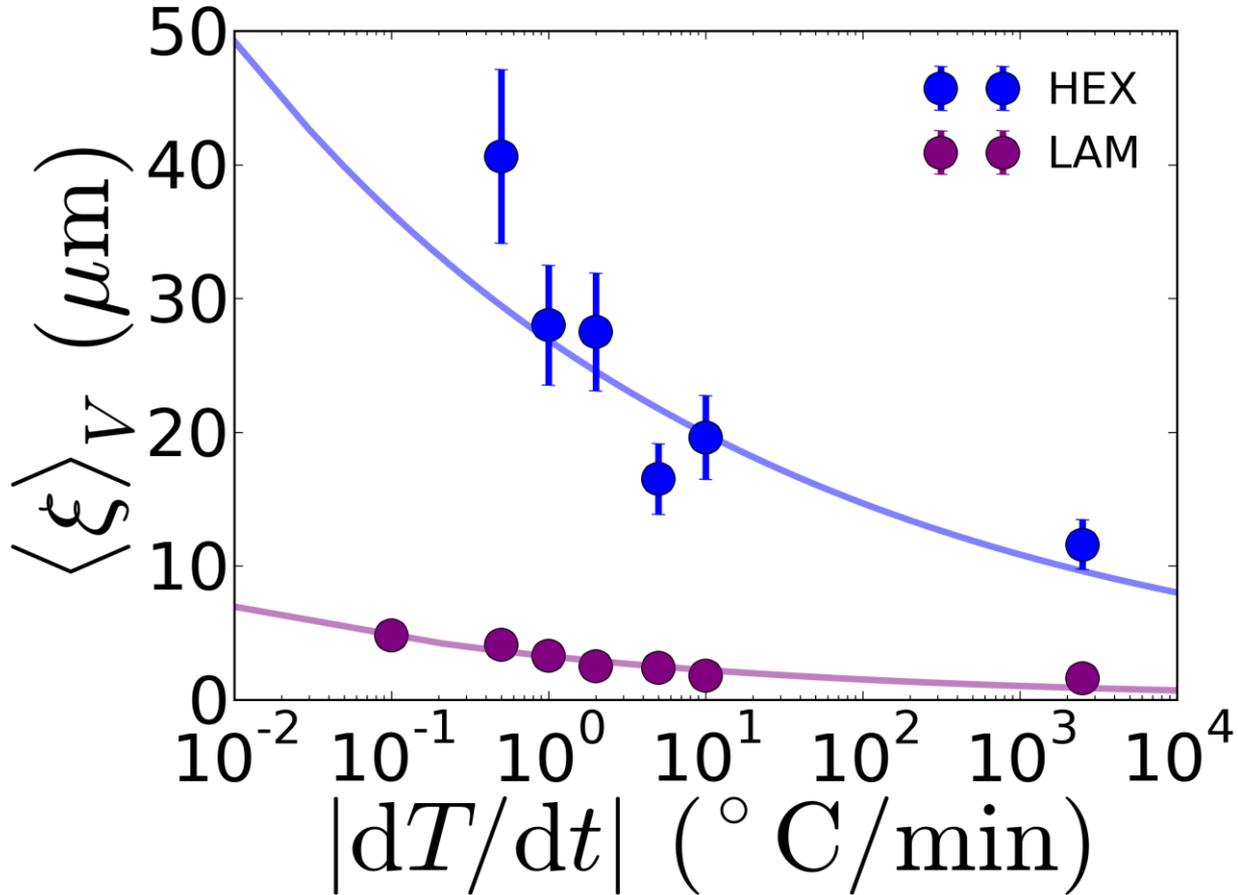
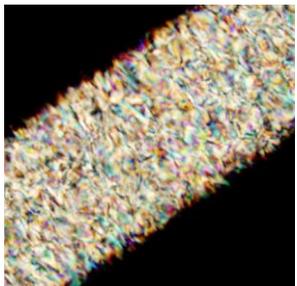
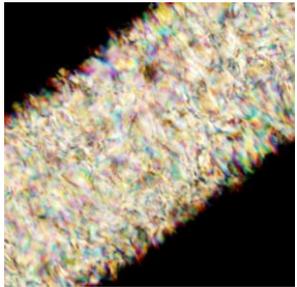
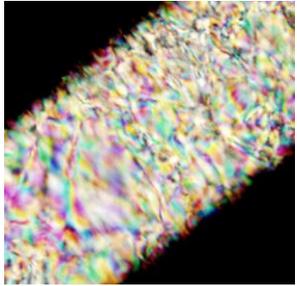
KY06\_cyl\_10p0Cmin\_7full\_10s\_SAXS-linecut



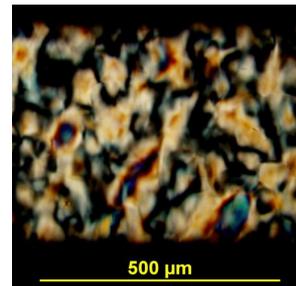
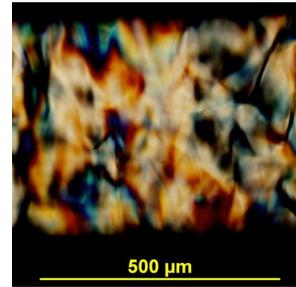
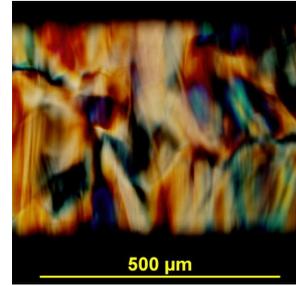
# Experimental

- We can measure variation in micron-sized grains, as a function of quench rate...

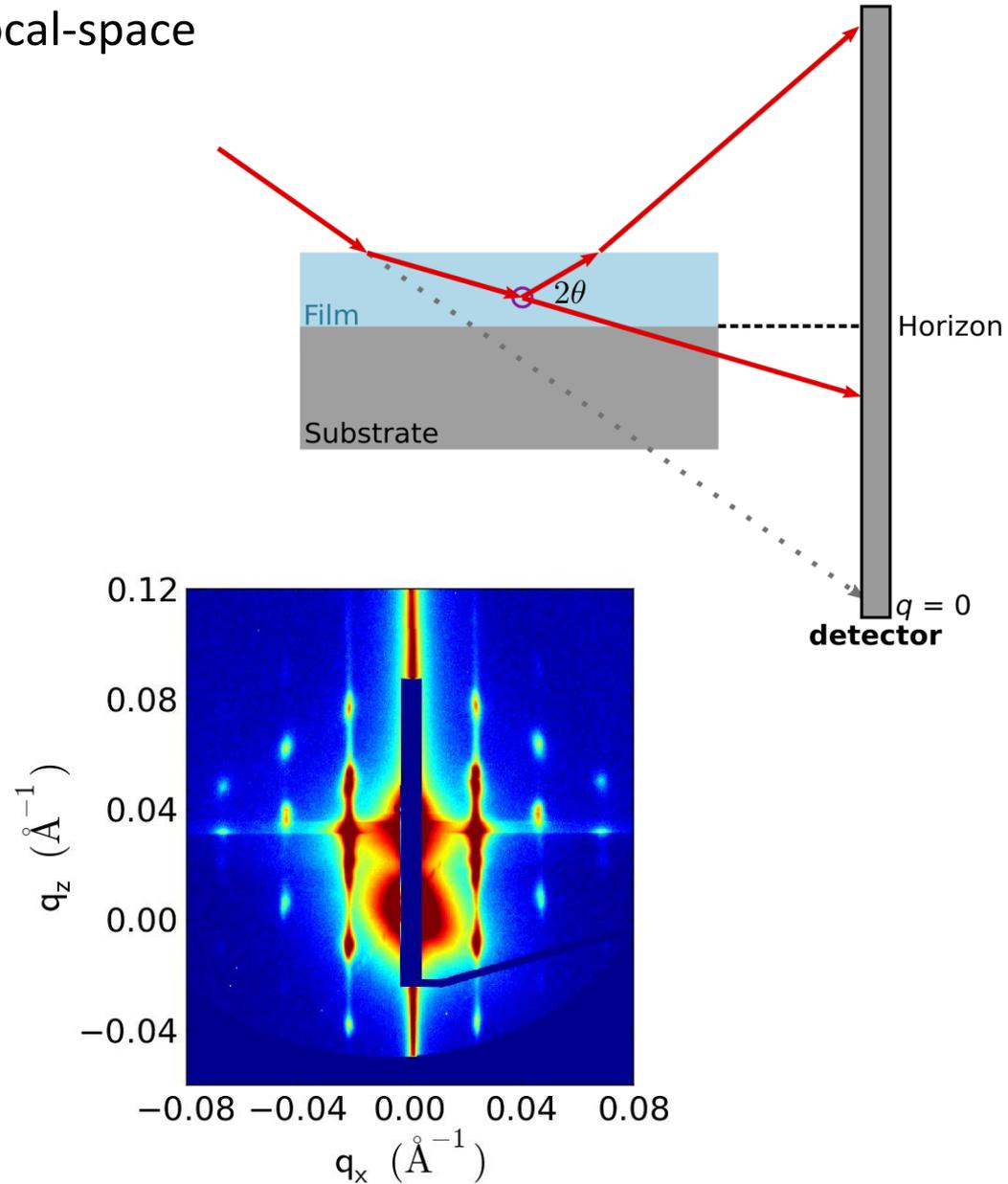
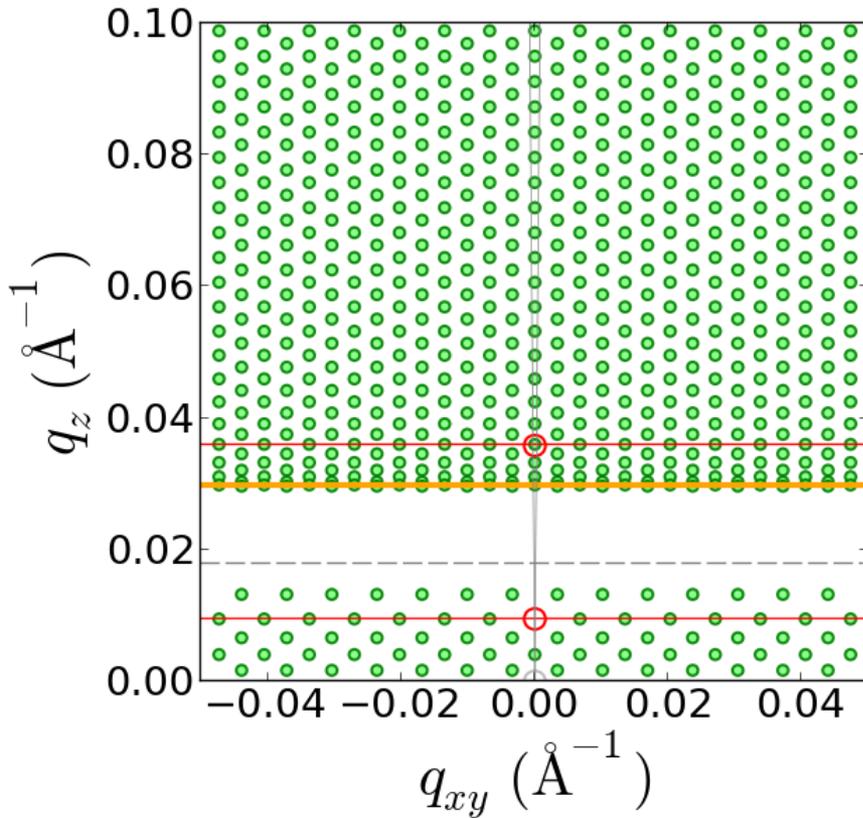
*lamellar*



*hexagonal*

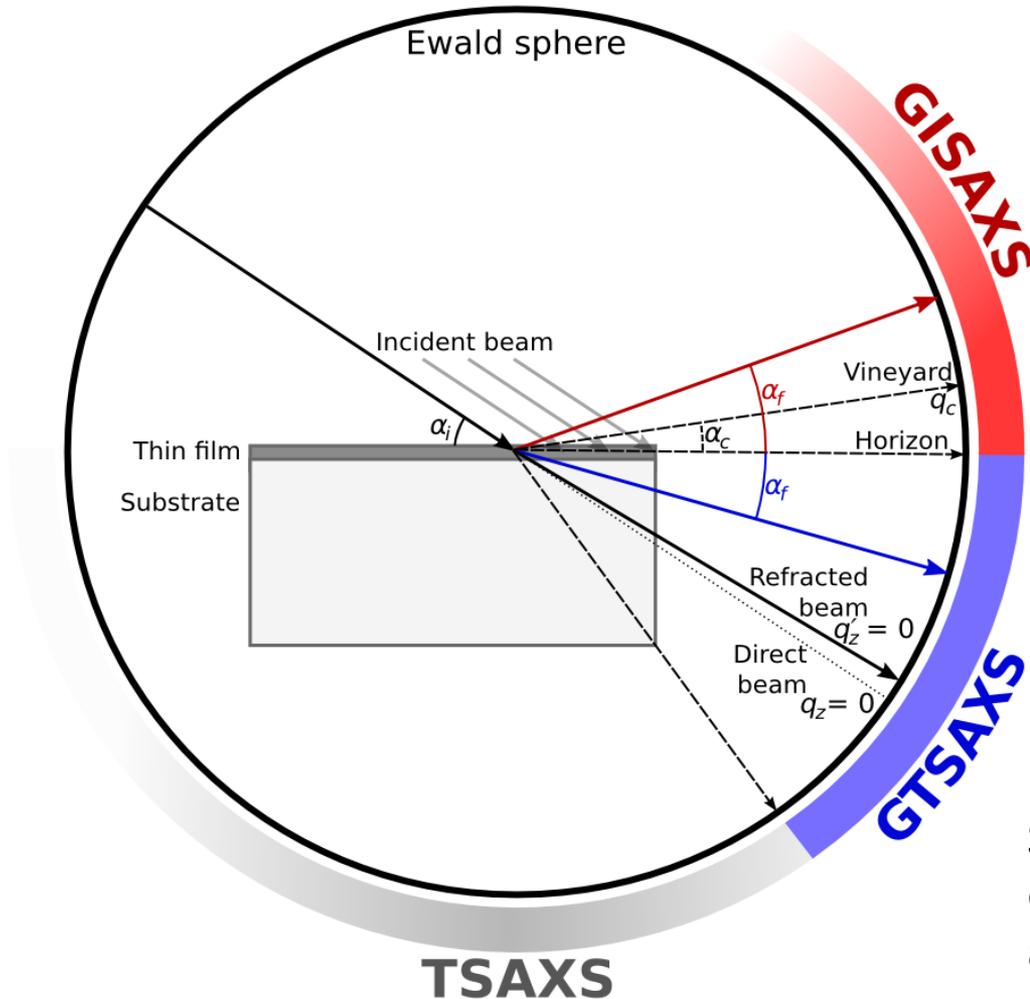


- Refraction shifts and distorts reciprocal-space



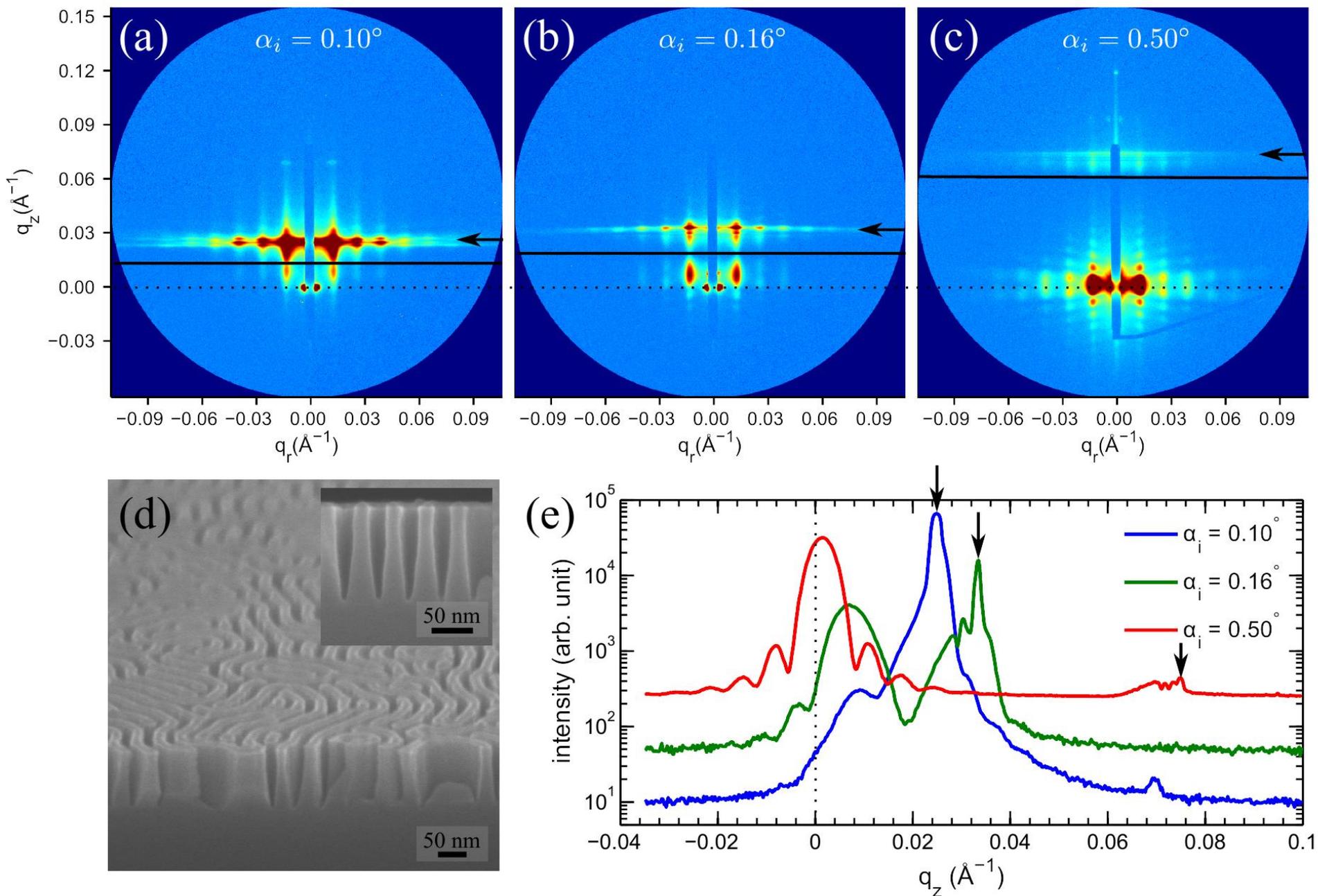
# New concept: GTSAXS

- Grazing-incidence Transmission Small-Angle X-ray Scattering



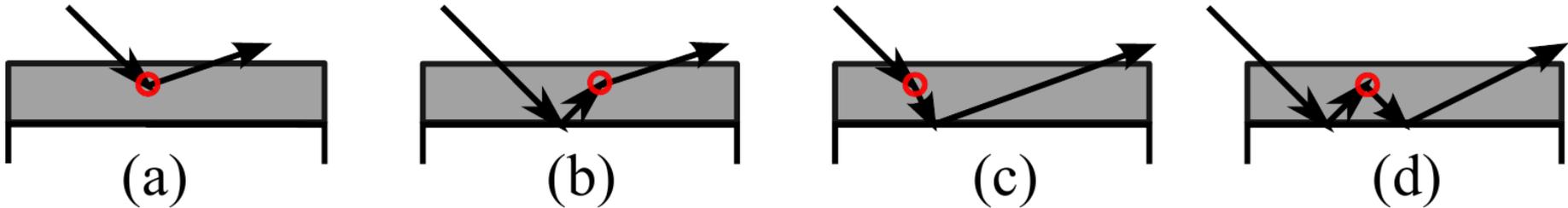
Scattering exits from edge (between horizon and sample corner)

# BCP pattern

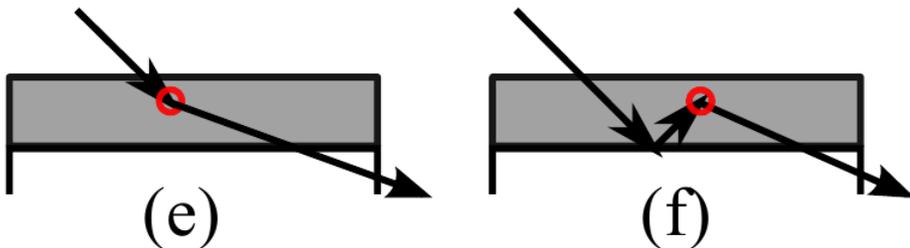


- Distorted-Wave Born Approximation (DWBA) considers 4 possible reflection-scattering events
- Born Approximation (BA) is much simpler: just a single scattering term

## GISAXS

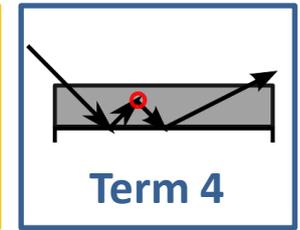
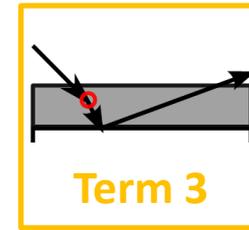
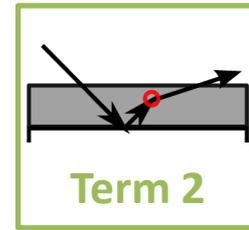
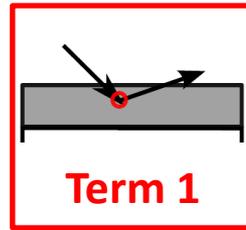
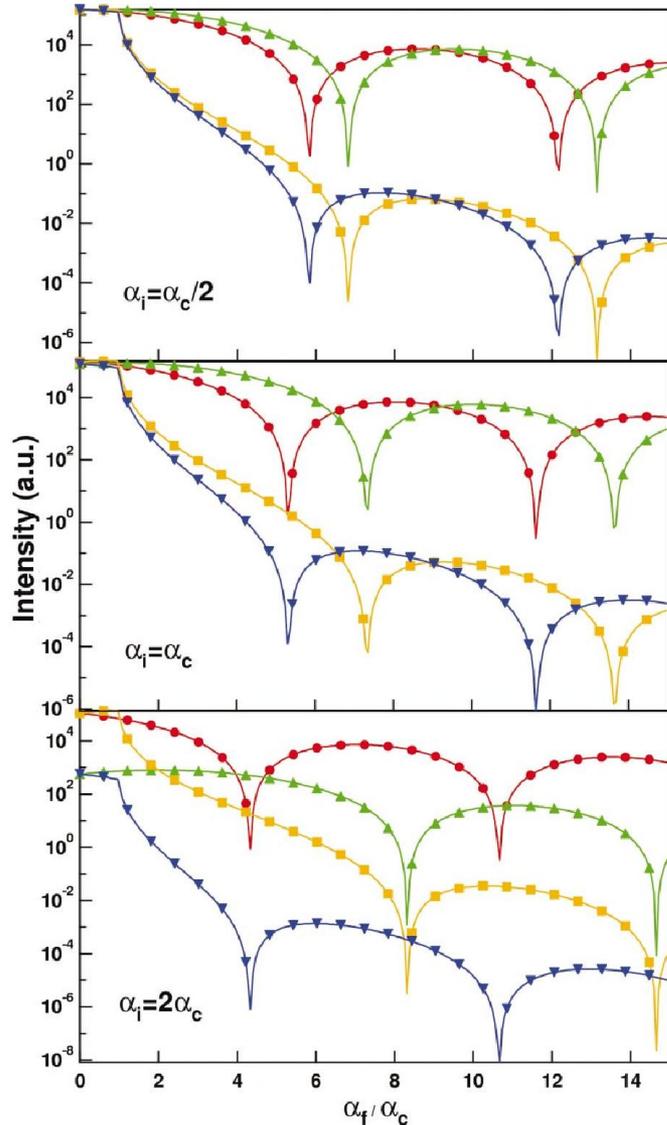


## GTSAXS

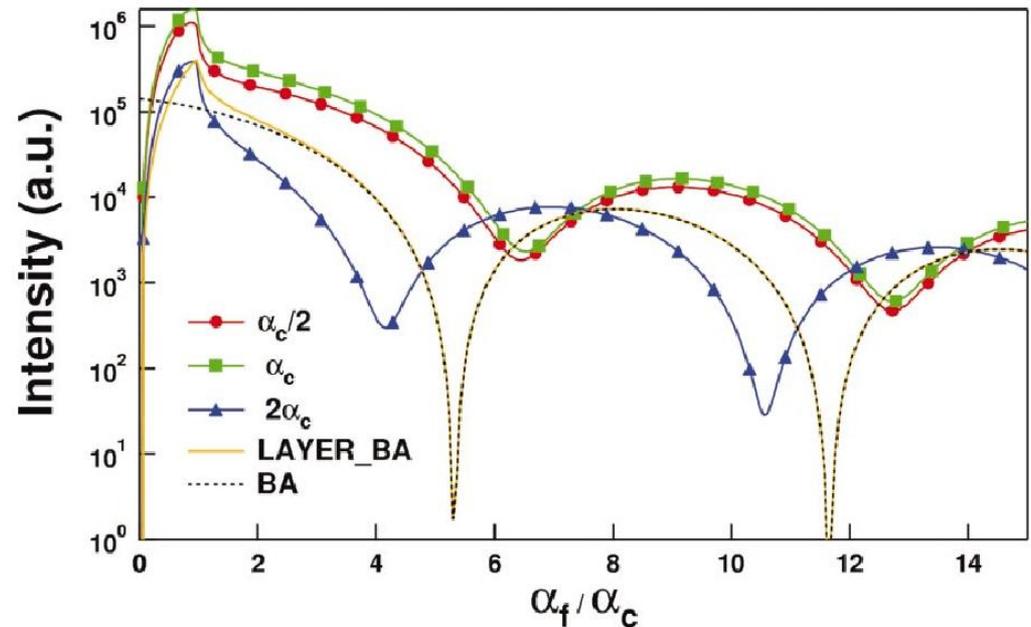


# Multiple Terms

- 4 terms of DWBA have different phases



Smears the minima of the BA



# Refraction correction

- Correction in GISAXS is large and nonlinear
- Correction in GTSAXS is just a small offset

## GISAXS

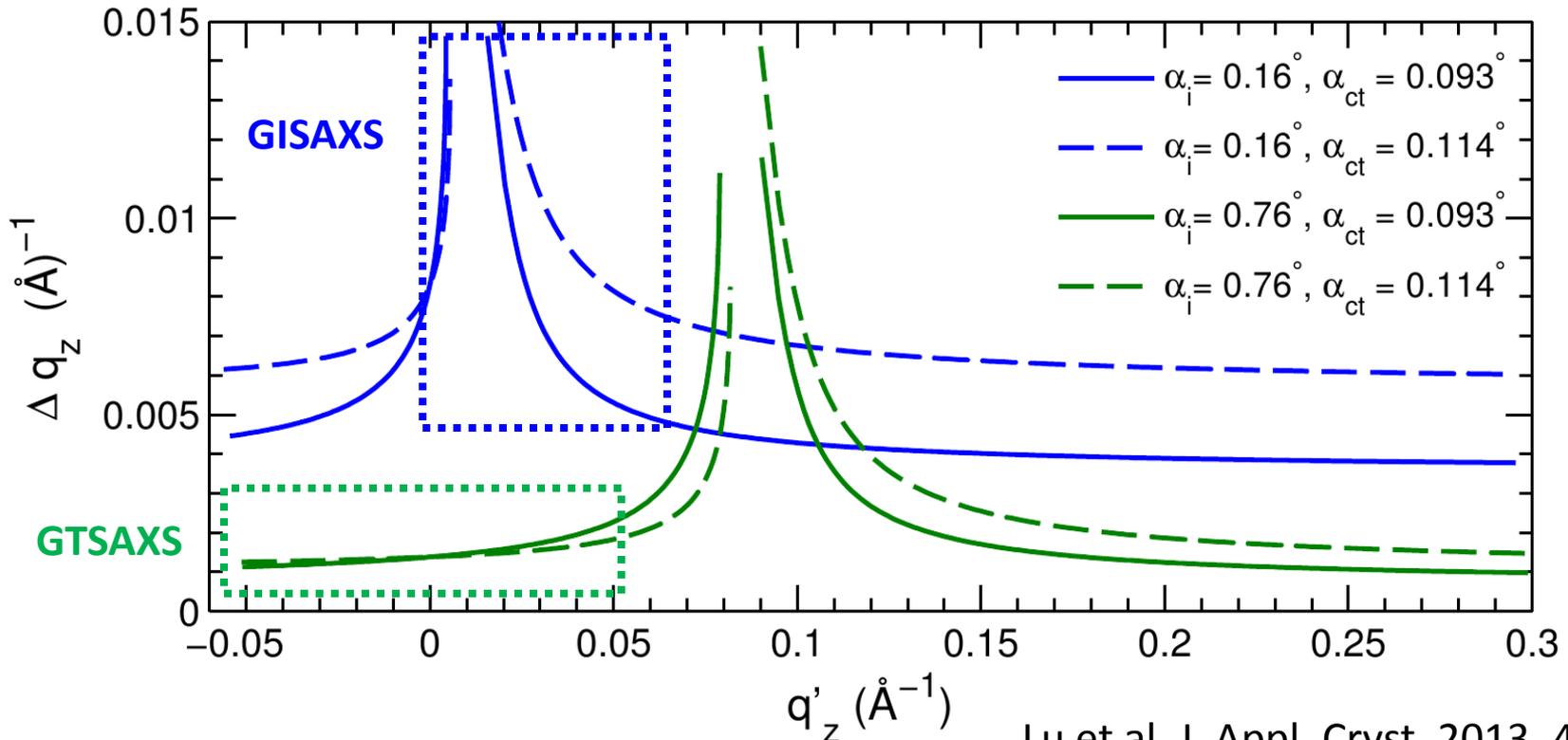
$$q'_z = k_0 \left( \sqrt{\sin^2 \alpha_i - \sin^2 \alpha_{ct}} + \sqrt{\sin^2 \alpha_f - \sin^2 \alpha_{ct}} \right)$$

$$= k_0 \left( \sqrt{\sin^2 \alpha_i - \sin^2 \alpha_{ct}} + \sqrt{\left( \frac{q_z}{k_0} - \sin \alpha_i \right)^2 - \sin^2 \alpha_{ct}} \right)$$

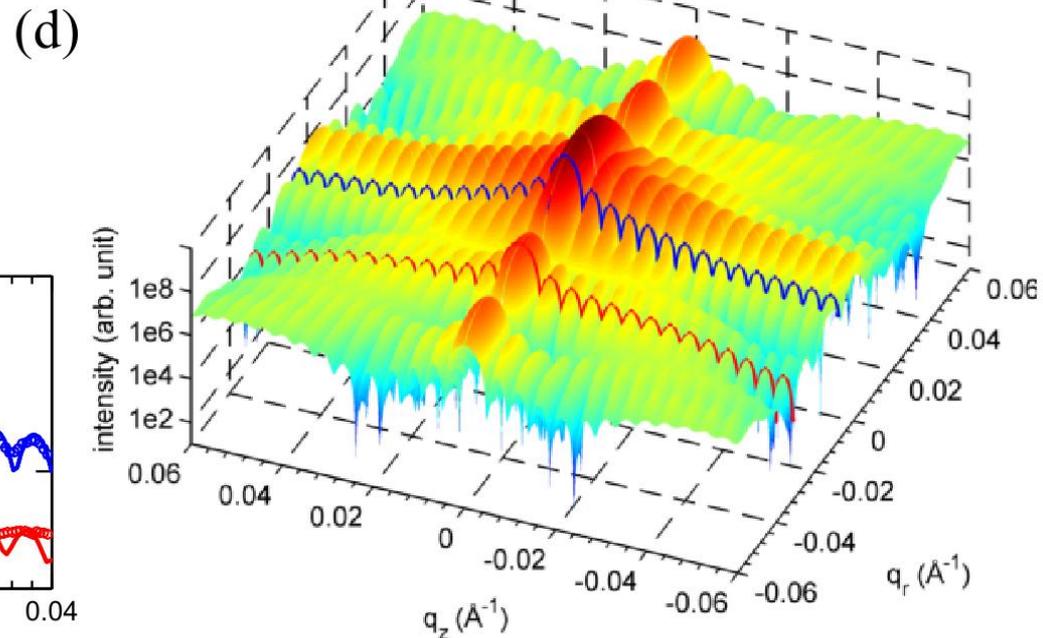
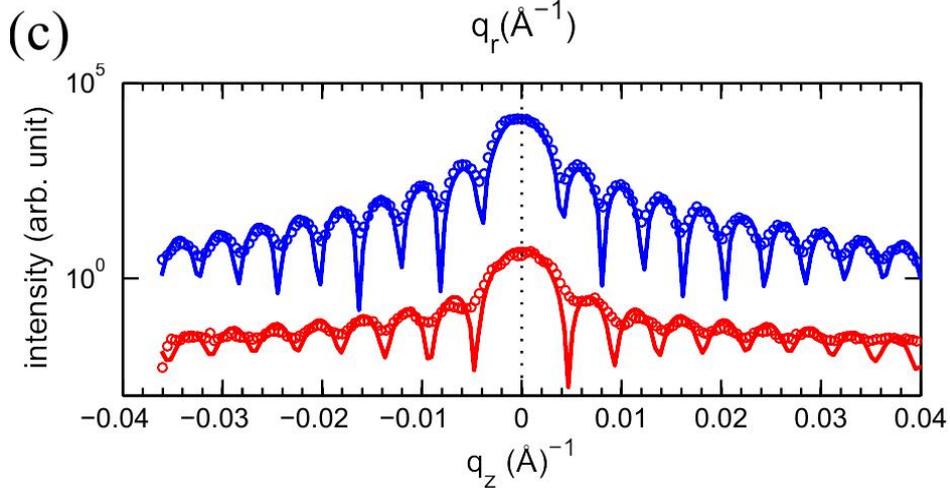
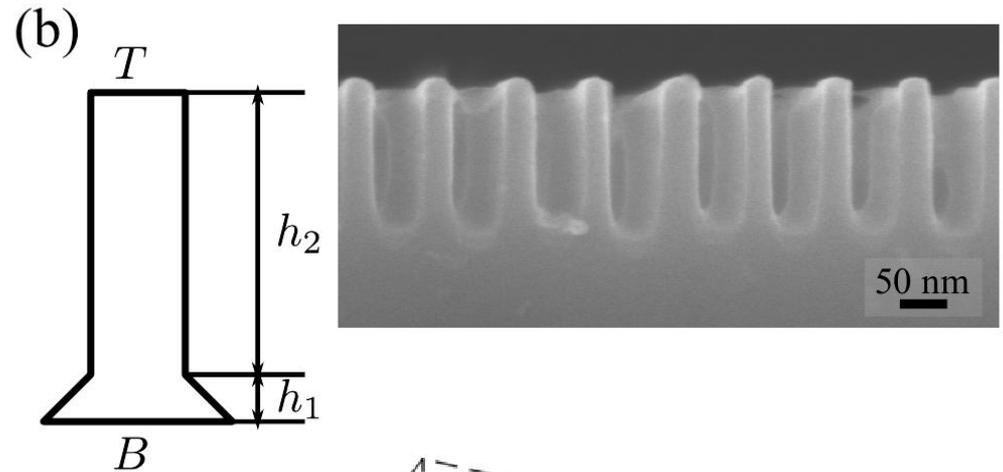
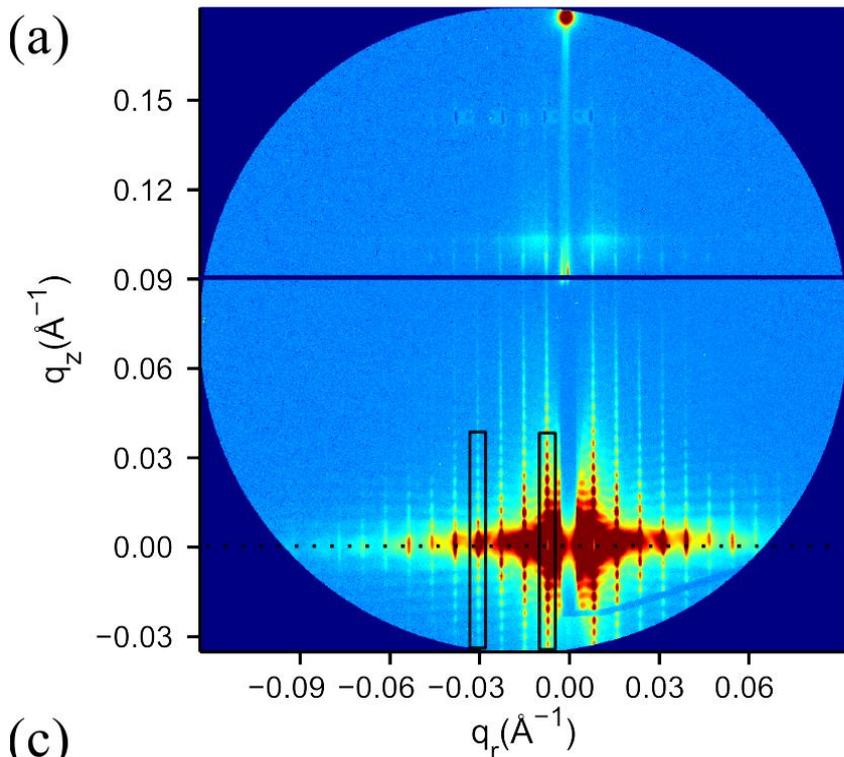
## GTSAXS

$$q'_z = k_0 \left( \sqrt{\sin^2 \alpha_i - \sin^2 \alpha_{ct}} - \sqrt{\sin^2 \alpha_f + \sin^2 \alpha_{Si} - \sin^2 \alpha_{ct}} \right)$$

$$= k_0 \left( \sqrt{\sin^2 \alpha_i - \sin^2 \alpha_{ct}} - \sqrt{\left( \frac{q_z}{k_0} - \sin \alpha_i \right)^2 + \sin^2 \alpha_{Si} - \sin^2 \alpha_{ct}} \right)$$

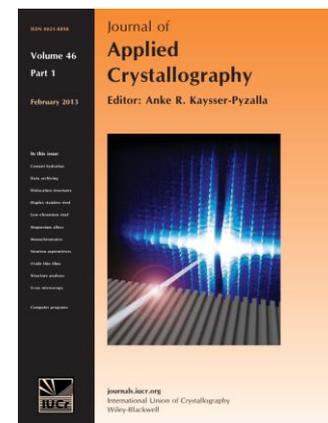
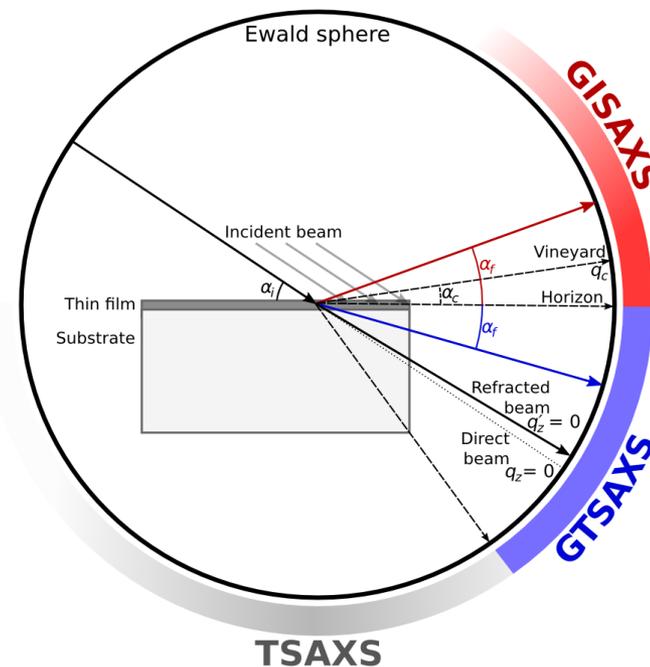


# Lithographic line grating

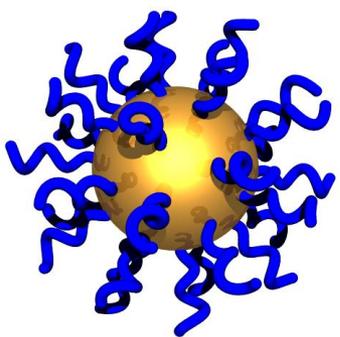
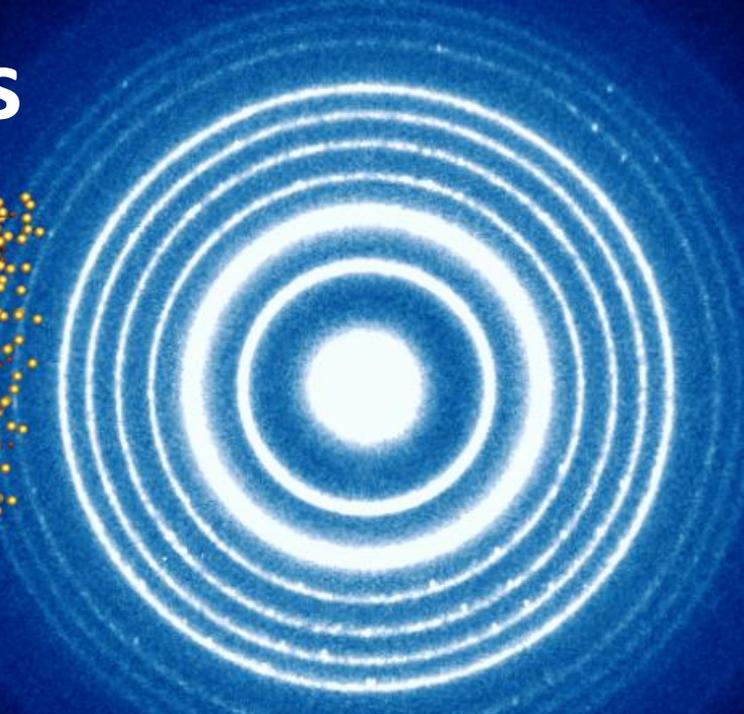
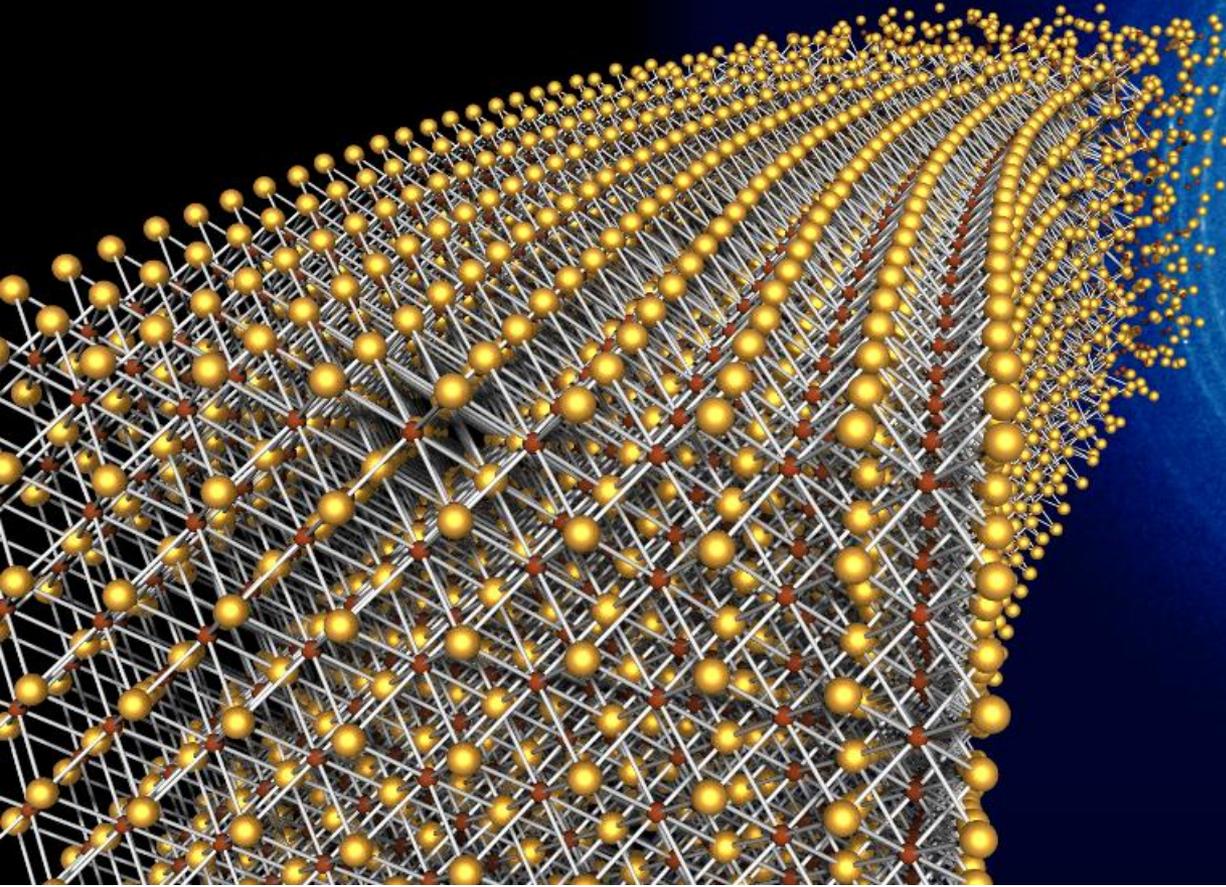


# GTSAXS Comparison

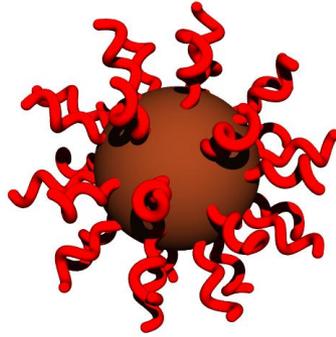
|                      | TSAXS  | GTSAXS  | GISAXS  |
|----------------------|--|---|---|
| <b>Requirements</b>  | Thin substrate                                       | Thin film<br>Flat substrate<br><u>Sample near edge</u><br>Focused beam<br><u>Beam near edge</u><br><u>Sufficient incident angle</u> | Thin film<br>Flat substrate<br>Focused beam<br>Low incident angle |
| <b>Advantages</b>    | Simple analysis                                      | Strong signal<br>qz data<br>Simple analysis   | Strong signal<br>qz data  |
| <b>Disadvantages</b> | Thin substrate<br>Weak signal<br><br>Limited qz data | Sample constraints  | Complex analysis  |



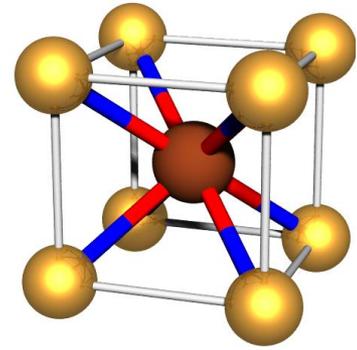
# Nanoparticle superlattices



+

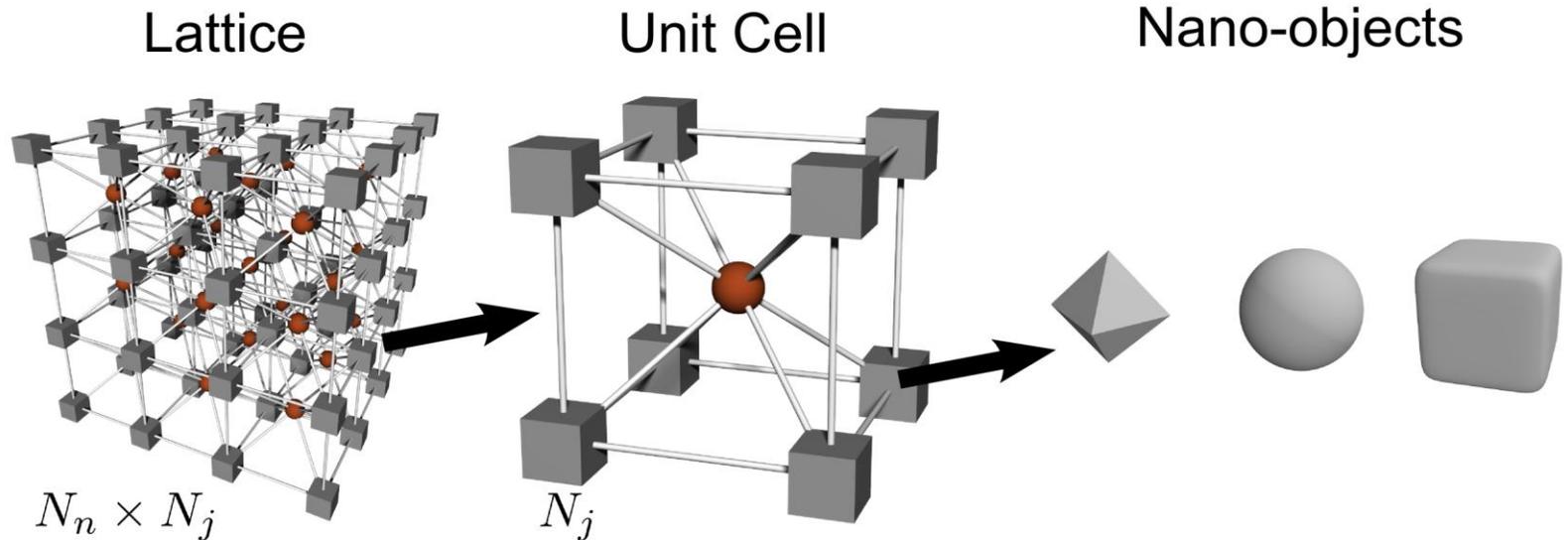


=



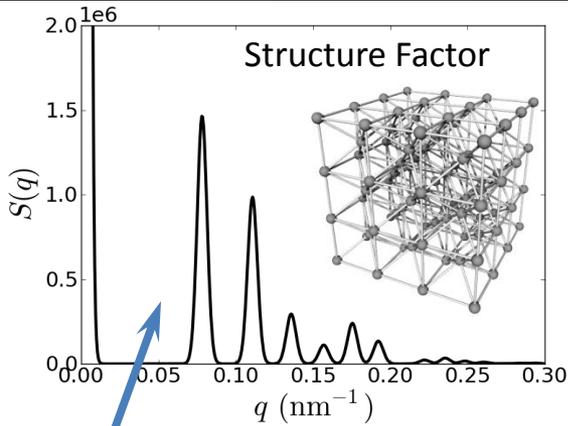
# Nano-lattice x-ray model

- Derived a very general scattering formalism
- Allows for arbitrary lattice of arbitrary nano-objects

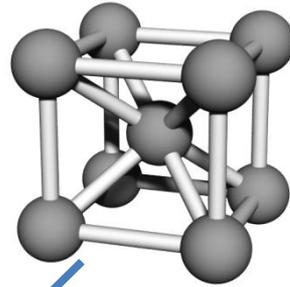


|            |                                 |  |   |
|------------|---------------------------------|--|---|
| Variables  |                                 |  |   |
| structural | grain size ( $\xi$ )            | symmetry<br>( $a, b, c, \alpha, \beta, \gamma$ ) | shape ( $p, \dots$ ), material ( $\Delta\rho$ ),<br>size ( $R$ ), orientation ( $M_j$ ) |
| disorder   | substitutional,<br>vacancy, ... | positional ( $\sigma_D$ )                        | polydispersity ( $\sigma_R/R$ ),<br>orientational                                       |
| Compute    | $I(q), S(q)$                    | $Z_0(q)$   | $F_j(\mathbf{q}), P_j(q)$   |

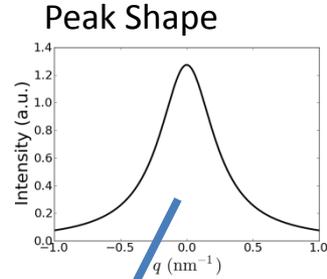
# Formalism



Lattice Unit Cell



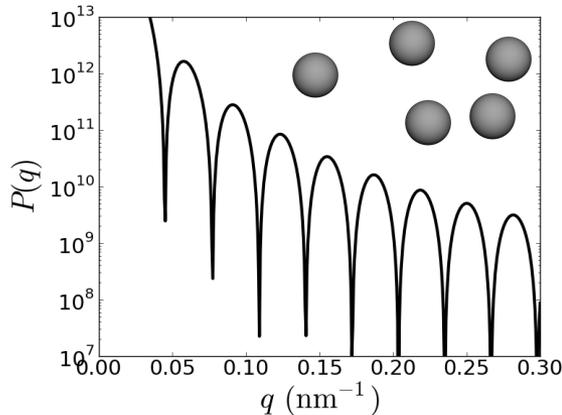
Plane Wave



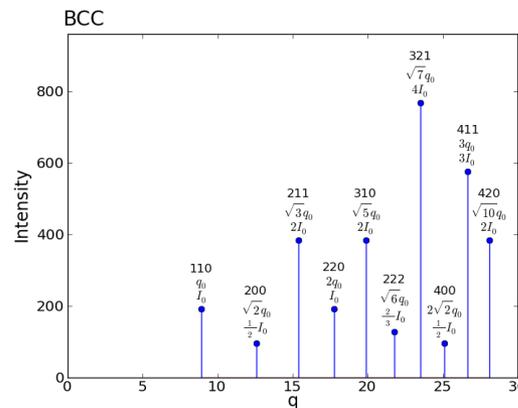
Debye-Waller  
(thermal disorder)

$$S(q) = \frac{c}{q_{hkl}^2 P(q_{hkl})} \sum_{\{hkl\}}^{m_{hkl}} \left| \sum_{j=1}^{n_c} F_j(M \cdot \mathbf{q}_{hkl}) e^{2\pi i(x_j h + y_j k + z_j l)} \right|^2 e^{-\sigma_D^2 q_{hkl}^2 a^2} L_{hkl}(q - q_{hkl})$$

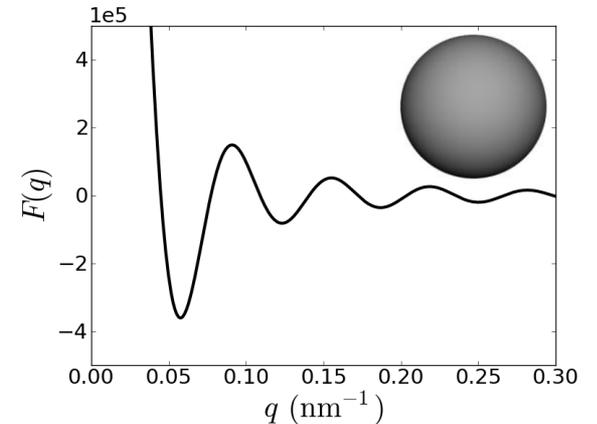
Isotropic Form Factor



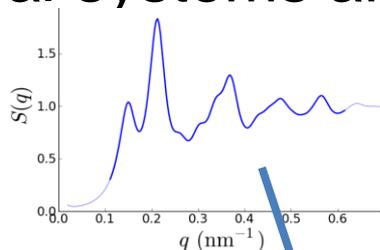
Reciprocal-space Peaks



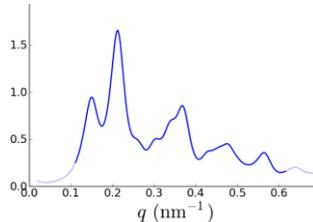
Particle Form Factor



- Real systems are disordered



Structural Peaks



Particle Size Polydispersity

$$\beta_j(q) = \frac{|\langle F_j(\mathbf{q}) \rangle|^2}{\langle |F_j(\mathbf{q})|^2 \rangle} = \frac{|\langle F_j(\mathbf{q}) \rangle|^2}{\bar{P}_j(q)}$$

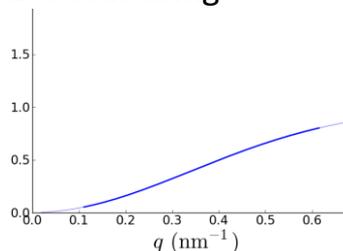
$$I(q) = P(q)S(q)$$

$$= P(q) \left[ \frac{cZ_0(q)}{P(q)} G(q) + \underbrace{1 - \beta(q)G(q)}_{\text{Diffuse Scattering}} \right]$$

Debye-Waller (thermal disorder)

$$G(q) = e^{-\sigma_D^2 q^2 a^2}$$

Diffuse Scattering

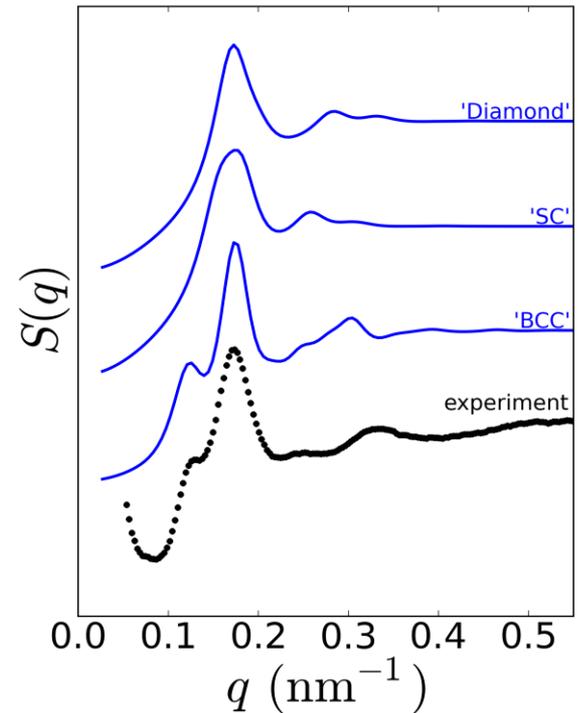
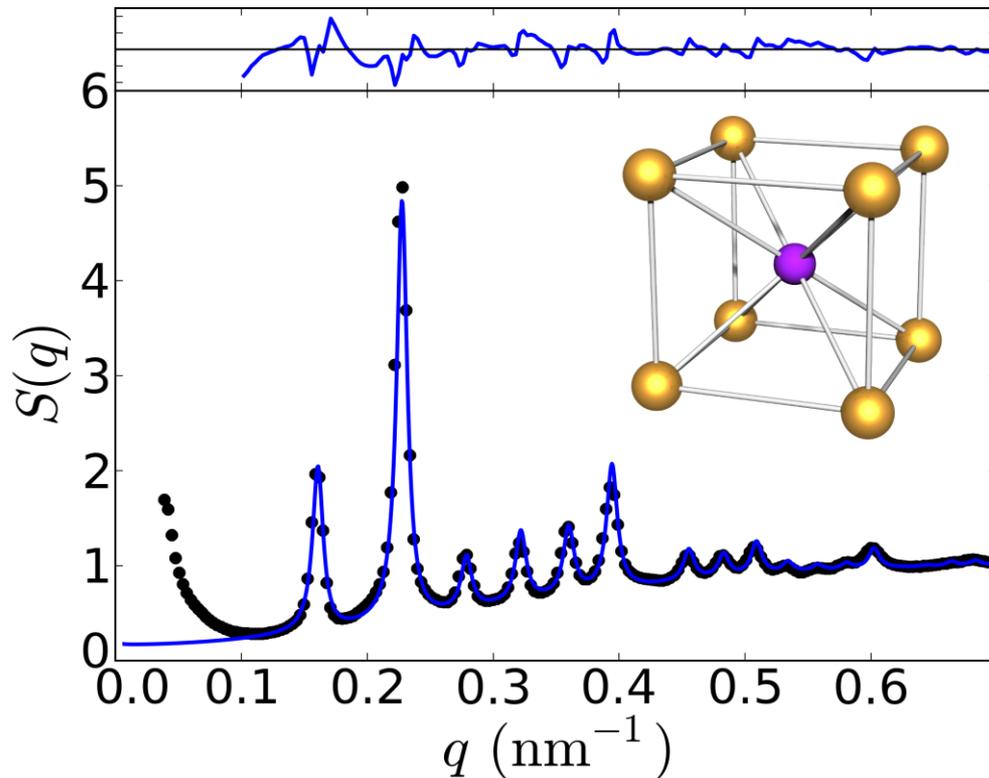


Peak shape/width  $L$  (contained within  $Z$ ) accounts for finite grain size

- Particle size polydispersity
- Grain size (correlation length)
- Positional disorder (DW)

# Fitting data

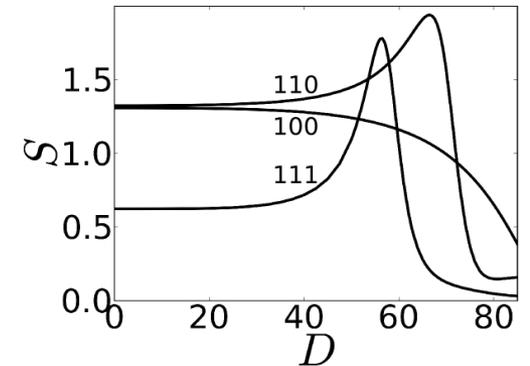
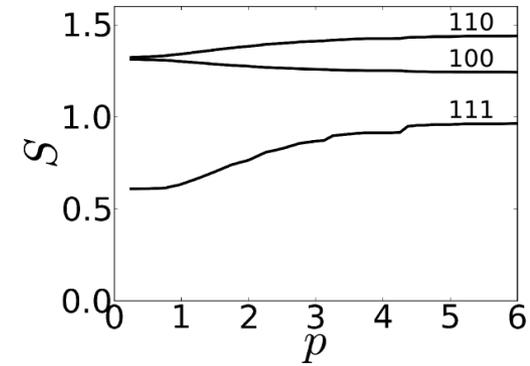
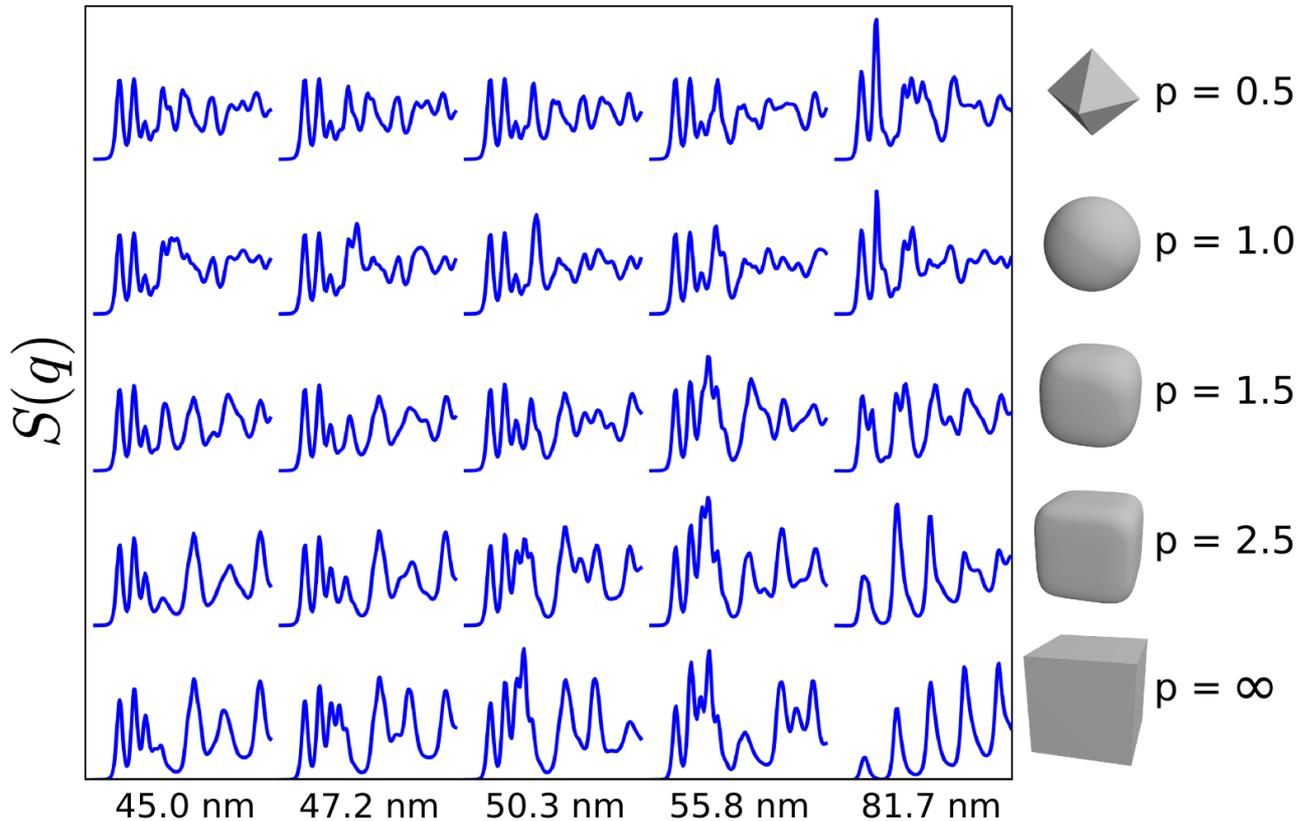
- Can fit experimental data quantitatively, extracting parameters of interest
- Constraining parameters (e.g. via SEM) helps
- Many parameters can be fit uniquely



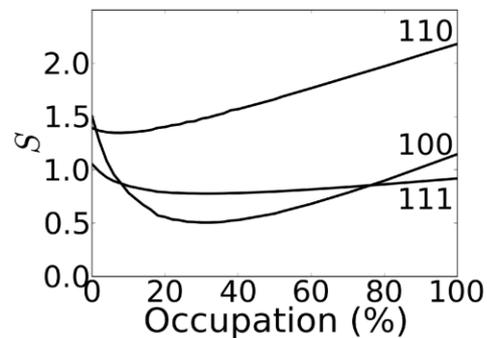
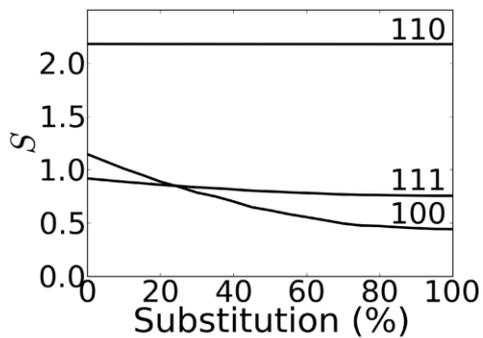
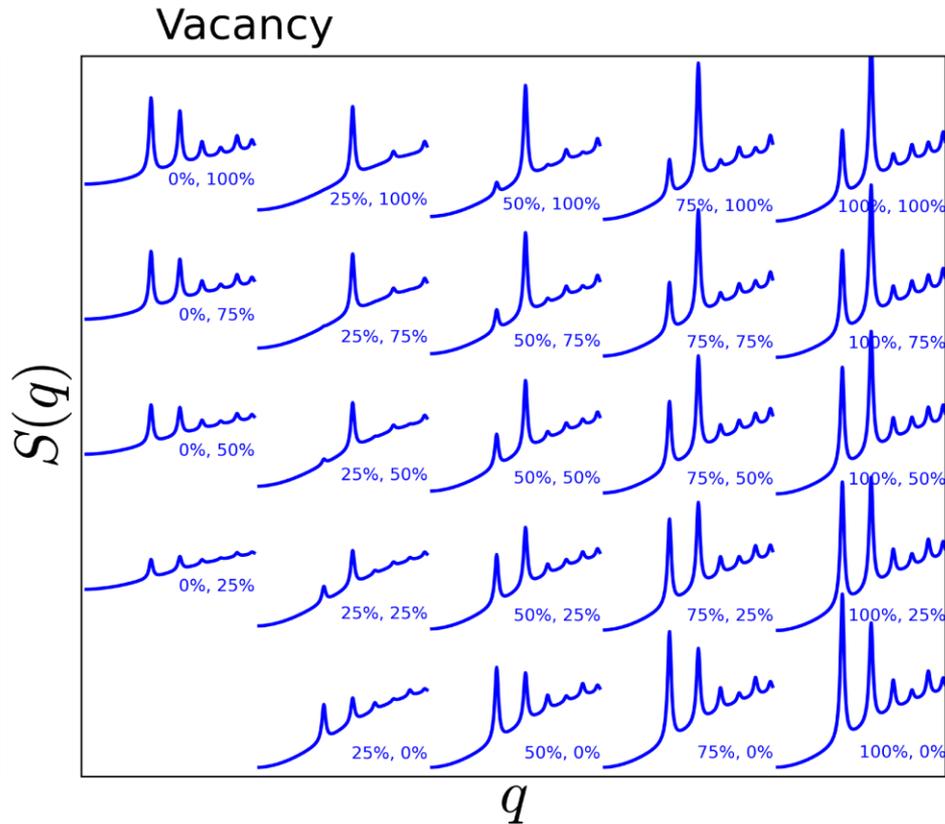
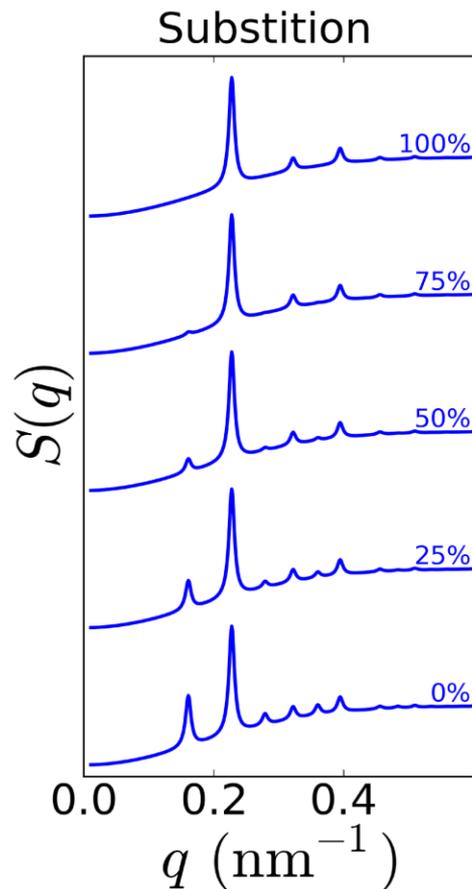
- Even in highly disordered systems, we can deduce structure...

# Particle Properties

- Nano-object size and shape modulates peak heights
- Can substantially alter prediction

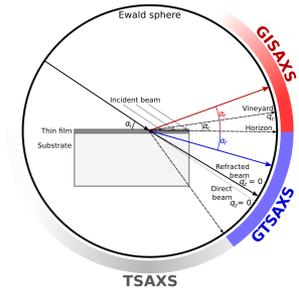


# Lattice Site Defects



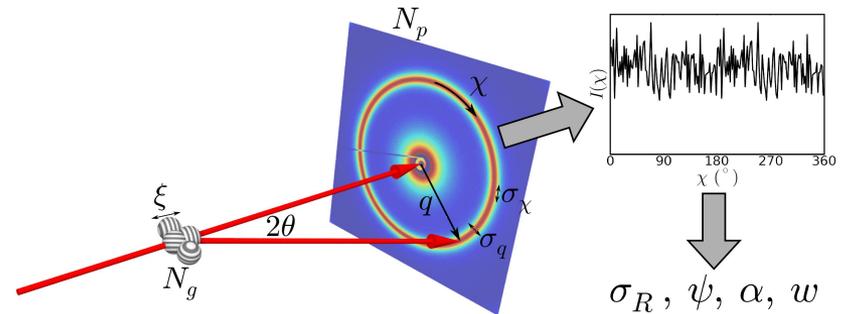
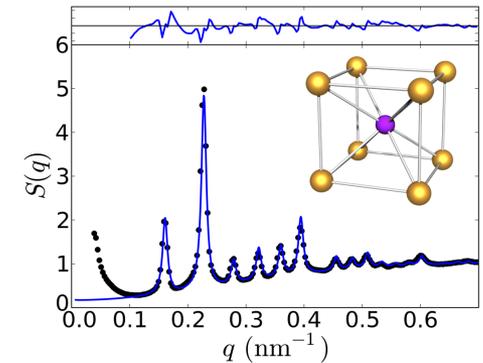
# Conclusions

- X-ray scattering a powerful way to measure nanostructured thin films



- New techniques being used to analyze more complex systems:

- Variance scattering for grain size & distribution
- GTSAXS for complex nanostructures
- New models for data fitting



# Acknowledgements

- BCP & Variance: Pawel Majewski
- P3HT & GTSAXS: Xinhui Lu, Ben Ocko, Dan Johnston, Charles Black
- Nano-lattices: Fang Lu, Yugang Zhang, Oleg Gang

